

## 14-BIT, 3-MSPS LOW POWER SAR ANALOG-TO-DIGITAL CONVERTER

### FEATURES

- 3 MHz Sample Rate, 14-Bit Resolution
- Zero Latency
- Unipolar, Pseudo Differential Input, Range:  
– 0 V to 2.5 V
- High Speed Parallel Interface
- 78 dB SNR and 88.5 dB THD at 3 MSPS
- Power Dissipation 85 mW at 3 MSPS
- Nap Mode (10 mW Power Dissipation)
- Power Down (10  $\mu$ W)
- Internal Reference
- Internal Reference Buffer
- 8-/14-Bit Bus Transfer
- 48-Pin TQFP Package

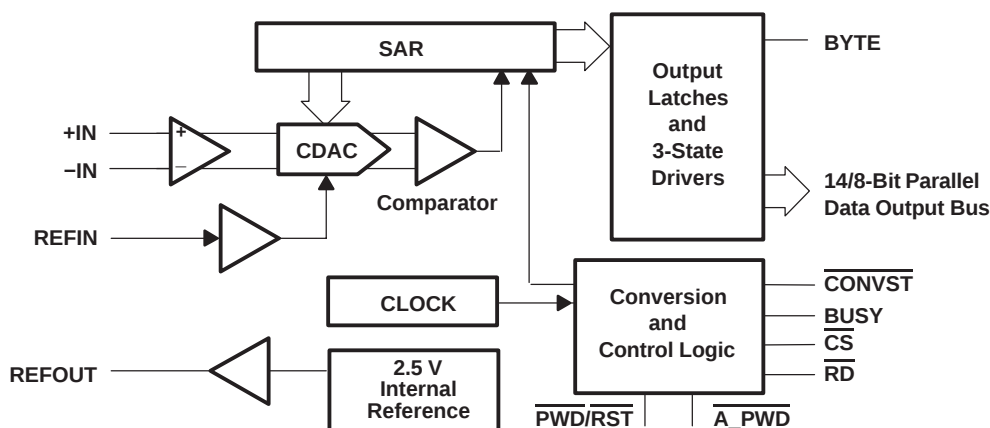
### APPLICATIONS

- Optical Networking (DWDM, MEMS Based Switching)
- Spectrum Analyzers
- High Speed Data Acquisition Systems
- High Speed Close-Loop Systems
- Telecommunication
- Ultra-Sound Detection

### DESCRIPTION

The ADS7891 is a 14-bit 3-MSPS A-to-D converter with 2.5-V internal reference. The device includes a capacitor based SAR A/D converter with inherent sample and hold. The device offers a 14-bit parallel interface with an additional byte mode that provides easy interface with 8-bit processors. The device has a pseudo-differential input stage.

The  $-IN$  swing of  $\pm 200$  mV is useful to compensate for ground voltage mismatch between the ADC and sensor and also to cancel common-mode noise. With nap mode enabled, the device operates at lower power when used at lower conversion rates. The device is available in a 48-pin TQFP package.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## ORDERING INFORMATION

| MODEL   | MAXIMUM INTEGRAL LINEARITY (LSB) | MAXIMUM DIFFERENTIAL LINEARITY (LSB) | NO MISSING CODES AT RESOLUTION (BIT) | PACKAGE TYPE | PACKAGE DESIGNATOR | TEMPERATURE RANGE | ORDERING INFORMATION | TRANSPORT MEDIA QUANTITY |
|---------|----------------------------------|--------------------------------------|--------------------------------------|--------------|--------------------|-------------------|----------------------|--------------------------|
| ADS7891 | ±1.5                             | +1.5/-1                              | 14                                   | 48-Pin TQFP  | PFB                | -40°C to 85°C     | ADS7891IPFBT         | Tape and reel<br>250     |
|         |                                  |                                      |                                      |              |                    |                   | ADS7891IPFBR         | Tape and reel<br>1000    |

NOTE: For most current specifications and package information, refer to the TI website at [www.ti.com](http://www.ti.com).

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range<sup>(1)</sup>

|                                           |                                   | UNIT                                                     |
|-------------------------------------------|-----------------------------------|----------------------------------------------------------|
| +IN to AGND                               |                                   | -0.3 V to +VA + 0.1 V                                    |
| -IN to AGND                               |                                   | -0.3 V to 0.5 V                                          |
| +VA to AGND                               |                                   | -0.3 V to 7 V                                            |
| +VBD to BDGND                             |                                   | -0.3 V to 7 V                                            |
| Digital input voltage to GND              |                                   | -0.3 V to (+VBD + 0.3 V)                                 |
| Digital output to GND                     |                                   | -0.3 V to (+VBD + 0.3 V)                                 |
| Operating temperature range               |                                   | -40°C to 85°C                                            |
| Storage temperature range                 |                                   | -65°C to 150°C                                           |
| Junction temperature (T <sub>Jmax</sub> ) |                                   | 150°C                                                    |
| TQFP package                              | Power dissipation                 | (T <sub>J</sub> Max - T <sub>A</sub> ) / θ <sub>JA</sub> |
|                                           | θ <sub>JA</sub> Thermal impedance | 86°C/W                                                   |
| Lead temperature, soldering               | Vapor phase (60 sec)              | 215°C                                                    |
|                                           | Infrared (15 sec)                 | 220°C                                                    |

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## SPECIFICATIONS

 $T_A = -40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ ,  $+V_A = 5\text{ V}$ ,  $+V_{BD} = 5\text{ V}$  or  $3.3\text{ V}$ ,  $V_{\text{ref}} = 2.5\text{ V}$ ,  $f_{\text{sample}} = 3\text{ MHz}$  (unless otherwise noted)

| PARAMETER                                | TEST CONDITIONS                                                                                       | MIN  | TYP        | MAX                    | UNIT               |
|------------------------------------------|-------------------------------------------------------------------------------------------------------|------|------------|------------------------|--------------------|
| <b>ANALOG INPUT</b>                      |                                                                                                       |      |            |                        |                    |
| Full-scale input span <sup>(1)</sup>     | +IN – (–IN)                                                                                           | 0    |            | $V_{\text{ref}}$       | V                  |
| Absolute input range                     | +IN                                                                                                   | –0.2 |            | $V_{\text{ref}} + 0.2$ | V                  |
|                                          | –IN                                                                                                   | –0.2 |            | +0.2                   |                    |
| Input capacitance                        |                                                                                                       |      | 27         |                        | pF                 |
| Input leakage current                    |                                                                                                       |      | 500        |                        | pA                 |
| <b>SYSTEM PERFORMANCE</b>                |                                                                                                       |      |            |                        |                    |
| Resolution                               |                                                                                                       |      | 14         |                        | Bits               |
| No missing codes                         |                                                                                                       | 14   |            |                        | Bits               |
| Integral linearity <sup>(2)</sup>        |                                                                                                       | –1.5 | $\pm 0.75$ | 1.5                    | LSB <sup>(3)</sup> |
| Differential linearity                   |                                                                                                       | –1   | $\pm 0.75$ | 1.5                    | LSB <sup>(3)</sup> |
| Offset error <sup>(4)</sup>              | External reference                                                                                    | –1.5 | $\pm 0.2$  | 1.5                    | mV                 |
| Gain error <sup>(4)</sup>                | External reference                                                                                    | –1   | $\pm 0.2$  | 1                      | mV                 |
| Common-mode rejection ratio              | With common mode input signal = 200 mVp–p at 1 MHz                                                    |      | 60         |                        | dB                 |
| Power supply rejection                   | At 3FF0H output code,<br>$+V_A = 4.75\text{ V}$ to $5.25\text{ V}$ , $V_{\text{ref}} = 2.50\text{ V}$ |      | 80         |                        | dB                 |
| <b>SAMPLING DYNAMICS</b>                 |                                                                                                       |      |            |                        |                    |
| Conversion time                          | +V <sub>BD</sub> = 5 V                                                                                |      | 255        | 273                    | nsec               |
|                                          | +V <sub>BD</sub> = 3 V                                                                                |      |            | 273                    | nsec               |
| Acquisition time                         | +V <sub>BD</sub> = 5 V                                                                                | 60   | 78         |                        | nsec               |
|                                          | +V <sub>BD</sub> = 3 V                                                                                | 60   |            |                        | nsec               |
| Maximum throughput rate                  |                                                                                                       |      |            | 3                      | MHz                |
| Aperture delay                           |                                                                                                       |      | 2          |                        | nsec               |
| Aperture jitter                          |                                                                                                       |      | 20         |                        | psec               |
| Step response                            |                                                                                                       |      | 50         |                        | nsec               |
| Over voltage recovery                    |                                                                                                       |      | 50         |                        | nsec               |
| <b>DYNAMIC CHARACTERISTICS</b>           |                                                                                                       |      |            |                        |                    |
| Total harmonic distortion <sup>(5)</sup> | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 100 kHz/2.5 V <sub>ref</sub>                                   |      | –93        |                        | dB                 |
|                                          | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1 MHz/2.5 V <sub>ref</sub>                                     |      | –88.5      | –87                    |                    |
|                                          | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1.4 MHz/2.5 V <sub>ref</sub>                                   |      | –79.5      |                        |                    |
| SNR                                      | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 100 kHz/2.5 V <sub>ref</sub>                                   |      | 78.5       |                        | dB                 |
|                                          | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1 MHz/2.5 V <sub>ref</sub>                                     |      | 78         |                        |                    |
|                                          | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1.4 MHz/2.5 V <sub>ref</sub>                                   |      | 75         |                        |                    |
| SINAD                                    | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 100 kHz/2.5 V <sub>ref</sub>                                   |      | 78         |                        | dB                 |
|                                          | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1 MHz/2.5 V <sub>ref</sub>                                     |      | 77         |                        |                    |
|                                          | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1.4 MHz/2.5 V <sub>ref</sub>                                   |      | 73.8       |                        |                    |
| SFDR                                     | $V_{\text{IN}} = 2.496\text{ Vp-p}$ at 1 MHz/2.5 V <sub>ref</sub>                                     | 88   | 90         |                        | dB                 |
| –3 dB Small signal bandwidth             |                                                                                                       |      | 50         |                        | MHz                |
| <b>EXTERNAL REFERENCE INPUT</b>          |                                                                                                       |      |            |                        |                    |
| Input V <sub>REF</sub> range             |                                                                                                       | 2.4  | 2.5        | 2.6                    | V                  |
| Resistance <sup>(6)</sup>                |                                                                                                       |      | 500        |                        | k $\Omega$         |

(1) Ideal input span; does not include gain or offset error.

(2) This is endpoint INL, not best fit.

(3) LSB means least significant bit.

(4) Measured relative to actual measured reference.

(5) Calculated on the first nine harmonics of the input frequency.

(6) Can vary  $\pm 20\%$ .

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## SPECIFICATIONS Continued

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| PARAMETER                                   |      | TEST CONDITIONS                                               | MIN             | TYP | MAX       | UNIT    |
|---------------------------------------------|------|---------------------------------------------------------------|-----------------|-----|-----------|---------|
| INTERNAL REFERENCE OUTPUT                   |      |                                                               |                 |     |           |         |
| Start-up time                               |      | From 95% (+VA), with 1-μF storage capacitor on REFOUT to AGND |                 |     | 120       | msec    |
| VREF Range                                  |      | IOUT=0                                                        | 2.48            | 2.5 | 2.52      | V       |
| Source current                              |      | Static load                                                   |                 |     | 10        | μA      |
| Line regulation                             |      | +VA = 4.75 V to 5.25 V                                        |                 | 1   |           | mV      |
| Drift                                       |      | IOUT = 0                                                      |                 | 25  |           | PPM/C   |
| DIGITAL INPUT/OUTPUT                        |      |                                                               |                 |     |           |         |
| Logic family                                |      |                                                               | CMOS            |     |           |         |
| Logic level                                 | VIH  | IIH = 5 μA                                                    | +VBD -1         |     | +VBD +0.3 | V       |
|                                             | VIL  | II L = 5 μA                                                   | -0.3            |     | 0.8       | V       |
|                                             | VOH  | IOH = 2 TTL loads                                             | +VBD - 0.6      |     | +VBD      | V       |
|                                             | VOL  | IOL = 2 TTL loads                                             | 0               |     | 0.4       | V       |
| Data format                                 |      |                                                               | Straight Binary |     |           |         |
| POWER SUPPLY REQUIREMENTS                   |      |                                                               |                 |     |           |         |
| Power supply voltage                        | +VBD |                                                               | 2.7             | 3.3 | 5.25      | V       |
|                                             | +VA  |                                                               | 4.75            | 5   | 5.25      | V       |
| Supply current, +VA, 3 MHz sample rate      |      |                                                               |                 | 17  | 18        | mA      |
| Power dissipation, 3 MHz sample rate        |      | +VA = 5 V                                                     |                 | 85  | 90        | mW      |
| NAP MODE                                    |      |                                                               |                 |     |           |         |
| Supply current, +VA                         |      |                                                               |                 | 2   | 3         | mA      |
| Power-up time(1)                            |      |                                                               |                 | 60  |           | nsec    |
| POWER DOWN                                  |      |                                                               |                 |     |           |         |
| Supply current, +VA                         |      |                                                               |                 | 2   | 2.5       | μA      |
| Power down time(2)                          |      | From simulation results                                       |                 | 10  |           | μsec    |
| Power up time                               |      | 1-μF Storage capacitor on REFOUT to AGND                      |                 | 25  |           | msec    |
| Invalid conversions after power up or reset |      |                                                               |                 |     | 4         | Numbers |
| TEMPERATURE RANGE                           |      |                                                               |                 |     |           |         |
| Operating free-air                          |      |                                                               | -40             |     | 85        | °C      |

<sup>(1)</sup> Minimum acquisition time for first sampling after the end of nap state must be 60 nsec more than normal.

<sup>(2)</sup> Time required to reach level of 2.5  $\mu\text{A}$ .

## TIMING REQUIREMENTS

All specifications typical at  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ ,  $+V_A = +5\text{ V}$ ,  $+V_{BD} = +5\text{ V}$  (see Notes 1, 2, 3, and 4)

| PARAMETER                                                                                                        | SYMBOL              | MIN  | TYP | MAX  | UNITS | REF FIG. |
|------------------------------------------------------------------------------------------------------------------|---------------------|------|-----|------|-------|----------|
| Conversion time                                                                                                  | $t_{(\text{conv})}$ |      | 255 | 273  | ns    | 5        |
| Acquisition time                                                                                                 | $t_{(\text{acq})}$  | 60   | 78  |      | ns    | 5        |
| <b>SAMPLING AND CONVERSION START</b>                                                                             |                     |      |     |      |       |          |
| Hold time $\overline{\text{CS}}$ low to $\overline{\text{CONVST}}$ high (with $\overline{\text{BUSY}}$ high)     | $t_{h1}$            | 10   |     |      | ns    | 3        |
| Delay $\overline{\text{CONVST}}$ high to acquisition start                                                       | $t_{d1}$            | 2    | 4   | 5    | ns    | 1        |
| Hold time, $\overline{\text{CONVST}}$ high to $\overline{\text{CS}}$ high with $\overline{\text{BUSY}}$ low      | $t_{h2}$            | 10   |     |      | ns    | 1        |
| Hold time, $\overline{\text{CONVST}}$ low to $\overline{\text{CS}}$ high                                         | $t_{h3}$            | 10   |     |      | ns    | 1        |
| Delay $\overline{\text{CONVST}}$ low to $\overline{\text{BUSY}}$ high                                            | $t_{d2}$            |      |     | 40   | ns    | 1        |
| $\overline{\text{CS}}$ width for acquisition or conversion to start                                              | $t_{w3}$            | 20   |     |      | ns    | 2        |
| Delay $\overline{\text{CS}}$ low to acquisition start with $\overline{\text{CONVST}}$ high                       | $t_{d3}$            | 2    | 4   | 5    | ns    | 2        |
| Pulse width, from $\overline{\text{CS}}$ low to $\overline{\text{CONVST}}$ low for acquisition to start          | $t_{w1}$            | 20   |     |      | ns    | 2        |
| Delay $\overline{\text{CS}}$ low to $\overline{\text{BUSY}}$ high with $\overline{\text{CONVST}}$ low            | $t_{d4}$            |      |     | 40   | ns    | 2        |
| Quiet sampling time <sup>(3)</sup>                                                                               |                     | 25   |     |      | ns    |          |
| <b>CONVERSION ABORT</b>                                                                                          |                     |      |     |      |       |          |
| Setup time $\overline{\text{CONVST}}$ high to $\overline{\text{CS}}$ low with $\overline{\text{BUSY}}$ high      | $t_{su1}$           |      |     | 15   | ns    | 4        |
| Delay time $\overline{\text{CS}}$ low to $\overline{\text{BUSY}}$ low with $\overline{\text{CONVST}}$ high       | $t_{d5}$            |      |     | 20   | ns    | 4        |
| <b>DATA READ</b>                                                                                                 |                     |      |     |      |       |          |
| Delay $\overline{\text{RD}}$ low to data valid with $\overline{\text{CS}}$ low                                   | $t_{d6}$            |      |     | 25   | ns    | 5        |
| Delay $\overline{\text{BYTE}}$ high to LSB word valid with $\overline{\text{CS}}$ and $\overline{\text{RD}}$ low | $t_{d7}$            |      |     | 25   | ns    | 5        |
| Delay time $\overline{\text{RD}}$ high to data 3-state with $\overline{\text{CS}}$ low                           | $t_{d9}$            |      |     | 25   | ns    | 5        |
| Delay time end of conversion to $\overline{\text{BUSY}}$ low                                                     | $t_{d11}$           |      |     | 20   | ns    | 5        |
| Quiet sampling time $\overline{\text{RD}}$ high to $\overline{\text{CONVST}}$ low                                | $t_1$               |      |     | 25   | ns    | 5        |
| Delay $\overline{\text{CS}}$ low to data valid with $\overline{\text{RD}}$ low                                   | $t_{d8}$            |      |     | 25   | ns    | 6        |
| Delay $\overline{\text{CS}}$ high to data 3-state with $\overline{\text{RD}}$ low                                | $t_{d10}$           |      |     | 25   | ns    | 6        |
| Quiet sampling time $\overline{\text{CS}}$ low to $\overline{\text{CONVST}}$ low                                 | $t_2$               |      |     | 25   | ns    | 6        |
| <b>BACK-TO-BACK CONVERSION</b>                                                                                   |                     |      |     |      |       |          |
| Delay $\overline{\text{BUSY}}$ low to data valid                                                                 | $t_{d12}$           |      |     | 10   | ns    | 7, 8     |
| Pulse width, $\overline{\text{CONVST}}$ high                                                                     | $t_{w4}$            | 70   |     |      | ns    | 7, 8     |
| Pulse width, $\overline{\text{CONVST}}$ low                                                                      | $t_{w5}$            | 20   |     |      | ns    | 7        |
| <b>POWER DOWN/RESET</b>                                                                                          |                     |      |     |      |       |          |
| Pulse width, low for $\overline{\text{PWD/RST}}$ to reset the device                                             | $t_{w6}$            | 45   |     | 6140 | ns    | 12       |
| Pulse width, low for $\overline{\text{PWD/RST}}$ to power down the device                                        | $t_{w7}$            | 7200 |     |      | ns    | 11       |
| Delay time, power up after $\overline{\text{PWD/RST}}$ is high                                                   | $t_{d13}$           |      |     | 25   | ms    | 11       |

(1) All input signals are specified with  $t_r = t_f = 5\text{ ns}$  (10% to 90% of  $+V_{BD}$ ) and timed from a voltage level of  $(V_{IL} + V_{IH})/2$ .

(2) See timing diagram.

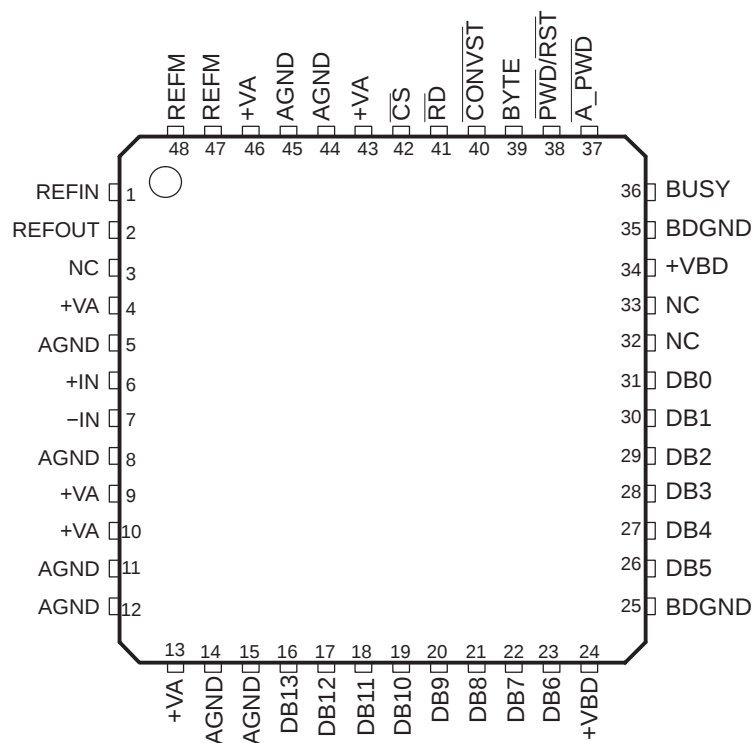
(3) Quiet period before conversion start, no data bus activity including data bus 3-state is allowed in this period.

(4) All timings are measured with 20 pF equivalent loads with 5 V  $+V_{BD}$  and 10-pF equivalent loads with 3 V  $+V_{BD}$  on all data bits and  $\overline{\text{BUSY}}$  pin.

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## PIN ASSIGNMENTS



NC – No connection

## Terminal Functions

| PIN                             | NAME                 | I/O | DESCRIPTION                                                                                                                                                                                                               |          |            |
|---------------------------------|----------------------|-----|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|------------|
| 16–23,<br>26–31                 | DATA BUS             |     | 8 BIT BUS                                                                                                                                                                                                                 |          | 16 BIT BUS |
|                                 | BYTE =               |     | 0                                                                                                                                                                                                                         | 1        | 0          |
| 16                              | DB13                 | O   | D13 (MSB)                                                                                                                                                                                                                 | D5       | D13 (MSB)  |
| 17                              | DB12                 | O   | D12                                                                                                                                                                                                                       | D4       | D12        |
| 18                              | DB11                 | O   | D11                                                                                                                                                                                                                       | D3       | D11        |
| 19                              | DB10                 | O   | D10                                                                                                                                                                                                                       | D2       | D10        |
| 20                              | DB9                  | O   | D9                                                                                                                                                                                                                        | D1       | D9         |
| 21                              | DB8                  | O   | D8                                                                                                                                                                                                                        | D0 (LSB) | D8         |
| 22                              | DB7                  | O   | D7                                                                                                                                                                                                                        | 0        | D7         |
| 23                              | DB6                  | O   | D6                                                                                                                                                                                                                        | 0        | D6         |
| 26                              | DB5                  | O   | D5                                                                                                                                                                                                                        | 0        | D5         |
| 27                              | DB4                  | O   | D4                                                                                                                                                                                                                        | 0        | D4         |
| 28                              | DB3                  | O   | D3                                                                                                                                                                                                                        | 0        | D3         |
| 29                              | DB2                  | O   | D2                                                                                                                                                                                                                        | 0        | D2         |
| 30                              | DB1                  | O   | D1                                                                                                                                                                                                                        | 0        | D1         |
| 31                              | DB0                  | O   | D0 (LSB)                                                                                                                                                                                                                  | 0        | D0 (LSB)   |
| 36                              | BUSY                 | O   | Status output. This pin is high when a conversion is in progress.                                                                                                                                                         |          |            |
| 39                              | BYTE                 | I   | Byte select input. Used for 8-bit bus reading.<br>0: No fold back.<br>1: Lower byte D[5:0] is folded back to high byte so D5 is available in D13 place.                                                                   |          |            |
| 40                              | CONVST               | I   | Conversion start. The rising edge starts the acquisition. The falling edge of this input ends the acquisition and starts the conversion. Refer to the timing diagrams for more details.                                   |          |            |
| 41                              | RD                   | I   | Active low synchronization pulse for the parallel output. When $\overline{CS}$ is low, this serves as the output enable and puts the previous conversion results on the bus.                                              |          |            |
| 37                              | A_PWD                | I   | Nap mode enable, active low                                                                                                                                                                                               |          |            |
| 24, 34                          | +VBD                 |     | Digital power supply for all digital inputs and outputs. Refer to Table 3 for layout guidelines.                                                                                                                          |          |            |
| 25, 35                          | BDGND                |     | Digital ground for all digital inputs and outputs. Needs to be shorted to analog ground plane below the device.                                                                                                           |          |            |
| 42                              | $\overline{CS}$      | I   | Chip Select. Active low signal enables chip operation like acquisition start, conversion start, bus release from 3-state. Refer to the timing diagrams for more details.                                                  |          |            |
| 38                              | $\overline{PWD/RST}$ | I   | Active low input, acts as device power down/device reset signal.                                                                                                                                                          |          |            |
| 5, 8, 11, 12, 14,<br>15, 44, 45 | AGND                 |     | Analog ground pins. Need to be shorted to analog ground plane below the device.                                                                                                                                           |          |            |
| 4, 9, 10, 13, 43,<br>46         | +VA                  |     | Analog power supplies. Refer to Table 3 for layout guidelines.                                                                                                                                                            |          |            |
| 6                               | +IN                  | I   | Non inverting analog input channel                                                                                                                                                                                        |          |            |
| 7                               | –IN                  | I   | Inverting analog input channel                                                                                                                                                                                            |          |            |
| 1                               | REFIN                | I   | Reference (positive) input. Needs to be decoupled with REFM pin using 0.1-μF bypass capacitor and 1-μF storage capacitor.                                                                                                 |          |            |
| 2                               | REFOUT               | O   | Internal reference output. To be shorted to REFIN pin when internal reference is used. Do not connect to REFIN pin when external reference is used. Always needs to be decoupled with AGND using 0.1-μF bypass capacitor. |          |            |
| 47, 48                          | REFM                 | I   | Reference ground. To be connected to analog ground plane.                                                                                                                                                                 |          |            |
| 3, 32, 33                       | NC                   |     | No connection pins.                                                                                                                                                                                                       |          |            |

## DESCRIPTION AND TIMING DIAGRAMS

### SAMPLING AND CONVERSION START

There are three ways to start sampling. The rising edge of  $\overline{\text{CONVST}}$  starts sampling with  $\overline{\text{CS}}$  and  $\text{BUSY}$  being low (see Figure 1) or it can be started with the falling edge of  $\overline{\text{CS}}$  when  $\overline{\text{CONVST}}$  is high and  $\text{BUSY}$  is low (see Figure 2). Sampling can also be started with an internal conversion end (before  $\text{BUSY}$  falling edge) with  $\overline{\text{CS}}$  being low and  $\overline{\text{CONVST}}$  high before an internal conversion end (see Figure 3). Also refer to the section DEVICE OPERATION AND DATA READ IN BACK-TO-BACK CONVERSION for more details.

A conversion can be started two ways (a conversion start is the end of sampling). Either with the falling edge of  $\overline{\text{CONVST}}$  when  $\overline{\text{CS}}$  is low (see Figure 1) or the falling edge of  $\overline{\text{CS}}$  when  $\overline{\text{CONVST}}$  is low (see Figure 2). A clean and low jitter falling edge of these respective signals triggers a conversion start and is important to the performance of the converter. The  $\text{BUSY}$  pin is brought high immediately following the  $\overline{\text{CONVST}}$  falling edge.  $\text{BUSY}$  stays high throughout the conversion process and returns low when the conversion has ended.

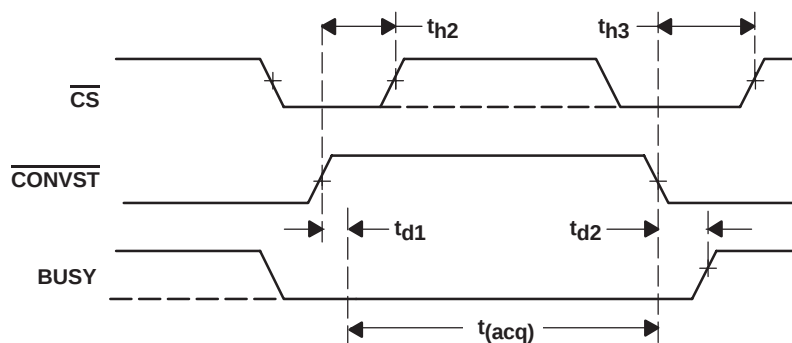


Figure 1. Sampling and Conversion Start Control With  $\overline{\text{CONVST}}$  Pin

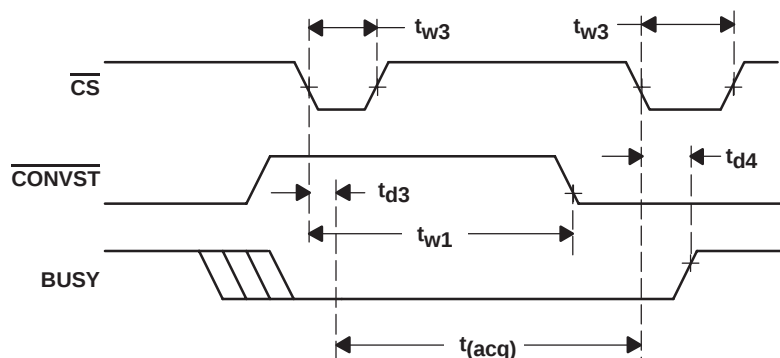


Figure 2. Sampling and Conversion Start Control With  $\overline{\text{CS}}$  Pin

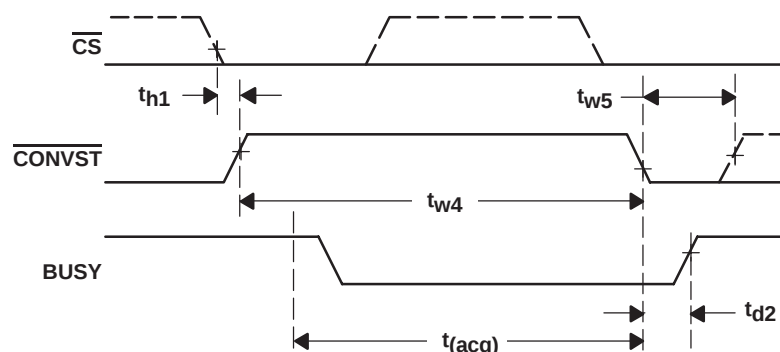


Figure 3. Sampling Start With  $\overline{\text{CS}}$  Low and  $\overline{\text{CONVST}}$  High (Back-to-Back)

## CONVERSION ABORT

The falling edge of  $\overline{CS}$  aborts the conversion while  $BUSY$  is high and  $\overline{CONVST}$  is high (see Figure 4). The device outputs 3F80 (hex) to indicate a conversion abort.

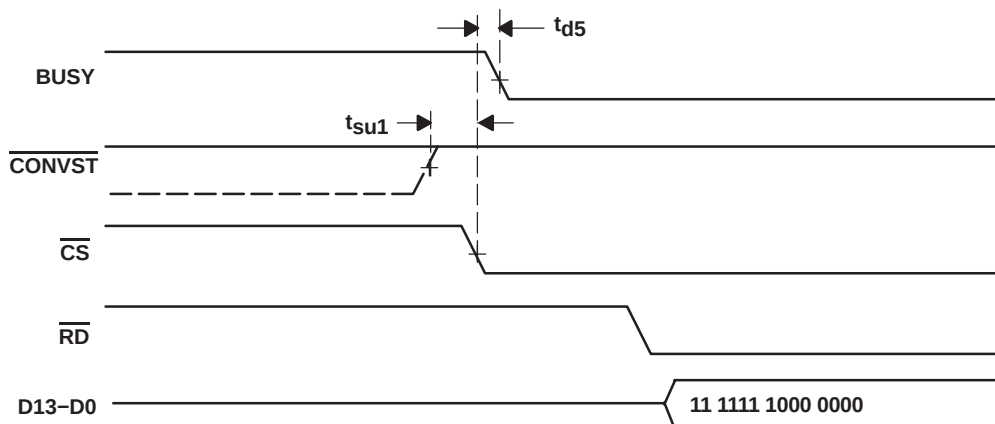


Figure 4. Conversion Abort

## DATA READ

Two conditions need to be satisfied for a read operation. Data appears on the D13 through D0 pins (with D13 MSB) when both  $\overline{CS}$  and  $\overline{RD}$  are low. Figure 5 and Figure 6 illustrate the device read operation. The bus is three-stated if any one of the signals is high.

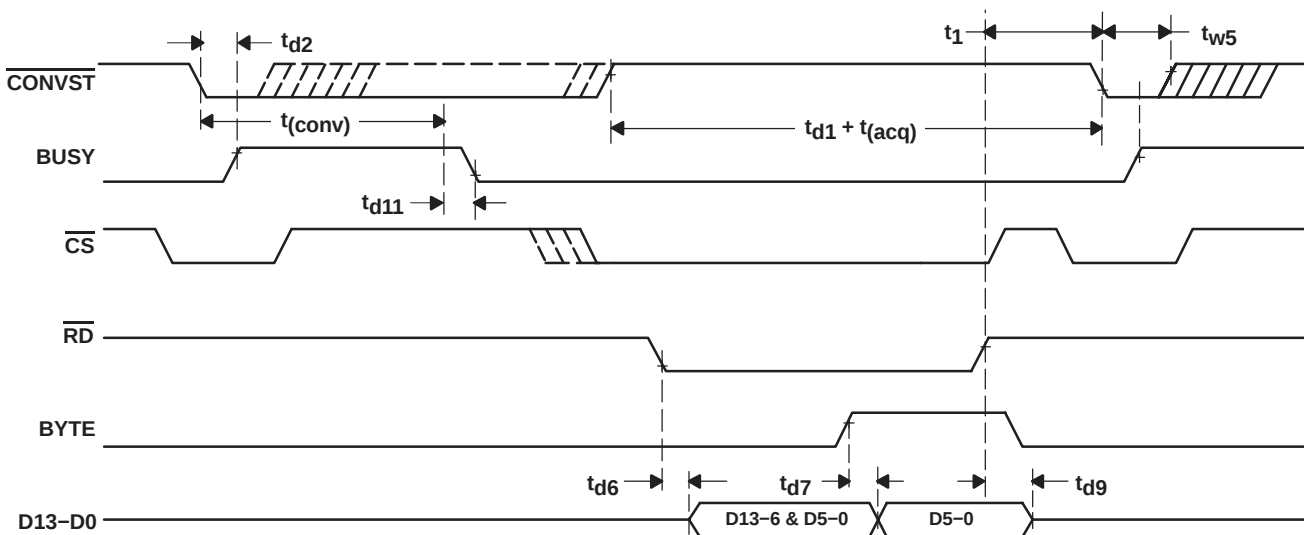


Figure 5. Read Control Via  $\overline{CS}$  and  $\overline{RD}$

There are two output formats available. Fourteen bit data appears on the bus during a read operation while  $BYTE$  is low. When  $BYTE$  is high, the lower byte (D5 through D0 followed by all zeroes) appears on the data bus with D5 in the MSB. This feature is useful for interfacing with eight bit microprocessors and microcontrollers.

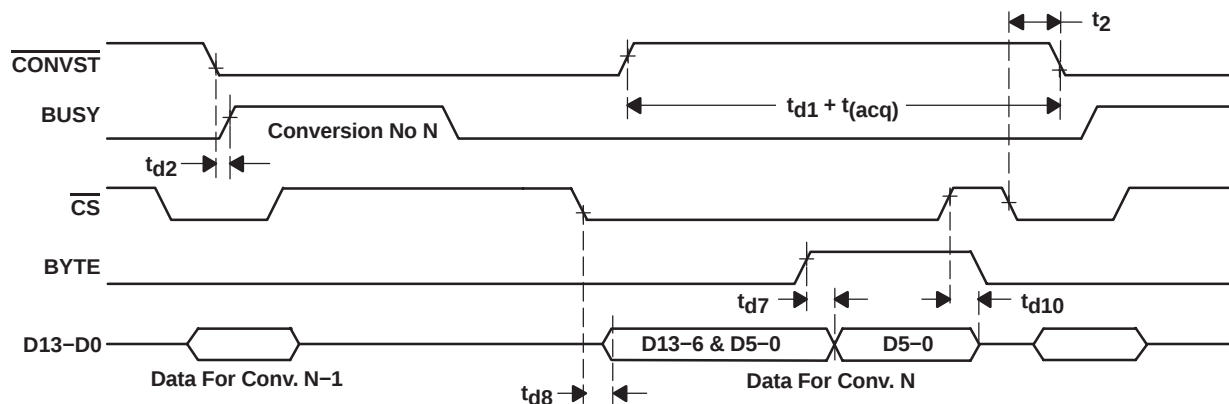


Figure 6. Read Control Via  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  Tied to BDGND

### DEVICE OPERATION AND DATA READ IN BACK-TO-BACK CONVERSION

The following two figures illustrate device operation in back-to-back conversion mode. It is possible to operate the device at any throughput in this mode, but this is the only mode in which the device can be operated at throughputs exceeding 2.8 MSPS.

A conversion starts on the  $\overline{\text{CONVST}}$  falling edge. The BUSY output goes high after a delay ( $t_{d2}$ ). Note that care must be taken not to abort the conversion (see Figure 4) apart from timing restrictions shown in Figure 7 and Figure 8. The conversion ends within the conversion time,  $t_{(\text{conv})}$ , after the  $\overline{\text{CONVST}}$  falling edge. The new acquisition can be immediately started without waiting for the BUSY signal to go low. This can be ensured with a  $\overline{\text{CONVST}}$  high pulse width that is more than or equal to  $(t_0 - t_{(\text{conv})} + 10 \text{ nsec})$  which is  $t_{w4}$  for a 3-MHz operation.

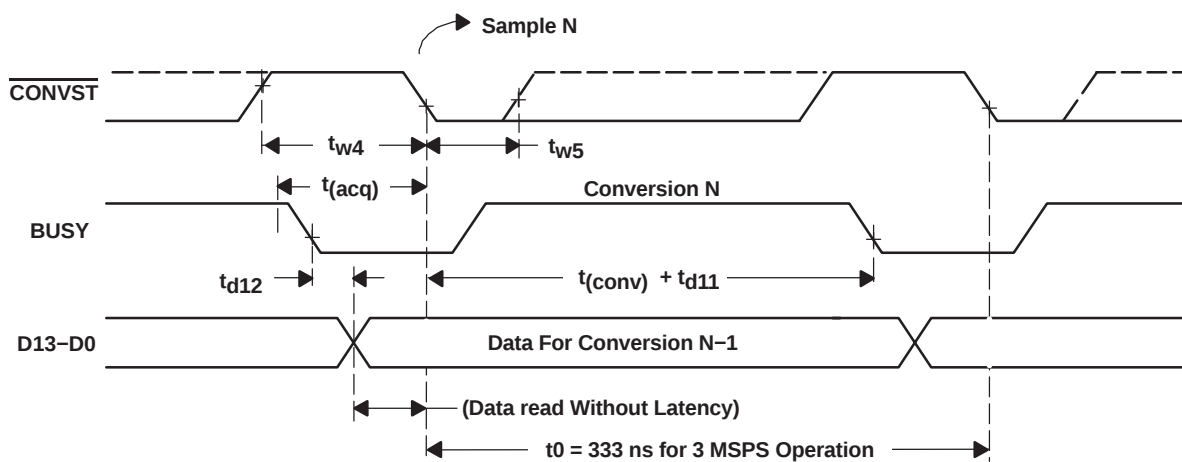


Figure 7. Back-To-Back Operation With  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  Low

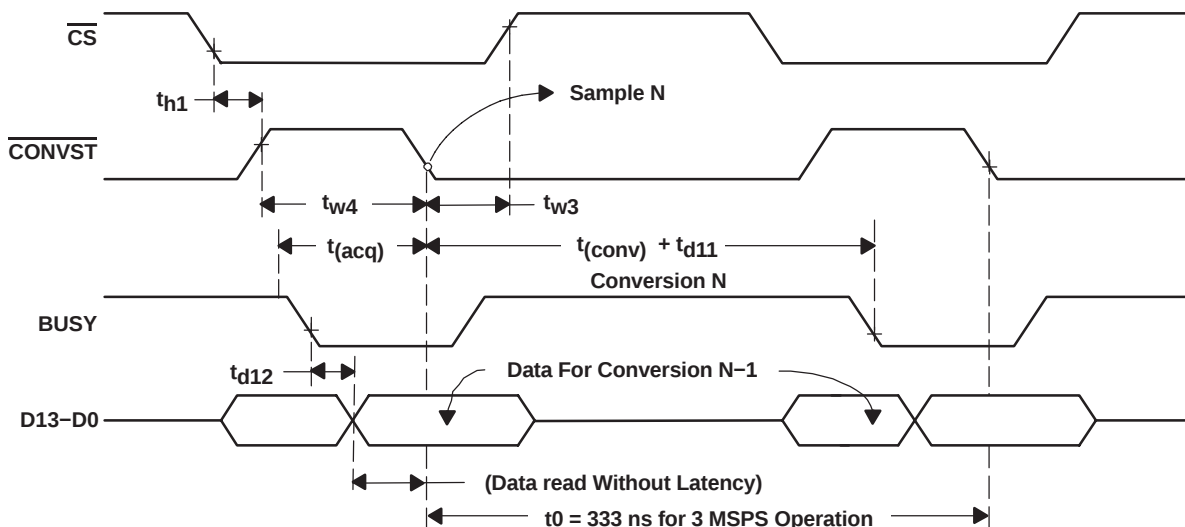


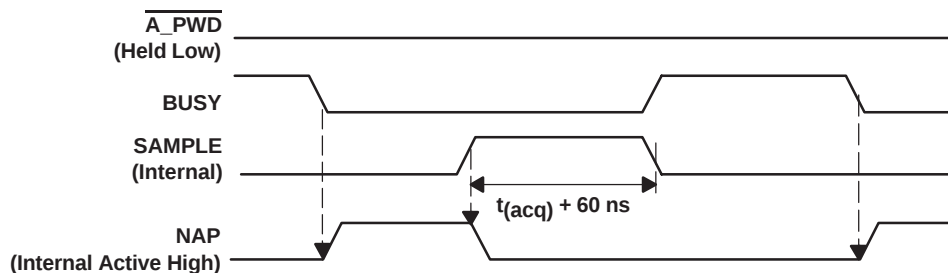
Figure 8. Back-To-Back operation With  $\overline{CS}$  Toggling and  $\overline{RD}$  Low

#### NAP MODE

The device can be put in nap mode following the sequences shown in Figure 9. This provides substantial power saving while operating at lower sampling rates.

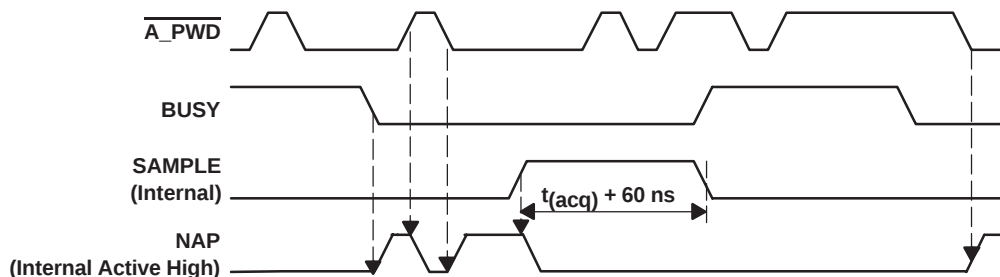
While operating the device at throughput rates lower than 2.54 MSPS,  $\overline{A\_PWD}$  can be held low (see Figure 9). In this condition, the device goes into the nap state immediately after  $BUSY$  goes low and remains in that state until the next sampling starts. The minimum acquisition time is 60 nsec more than  $t_{(acq)}$  as defined in the timing requirements section.

Alternately,  $\overline{A\_PWD}$  can be toggled any time during operation (see Figure 10). This is useful when the system acquires data at the maximum conversion speed for some period of time (back-to-back conversion) and it does not acquire data for some time while the acquired data is being processed. During this period, the device can be put in the nap state to save power. The device remains in the nap state as long as  $\overline{A\_PWD}$  is low with  $BUSY$  being low and sampling has not started. The minimum acquisition time for the first sampling after the nap state is 60 nsec more than  $t_{(acq)}$  as defined in the timing requirements section.



NOTE: The SAMPLE (Internal) signal is generated as described in the Sampling and Conversion Start section.

Figure 9. Device Operation While  $\overline{A\_PWD}$  is Held Low



NOTE: The SAMPLE (Internal) signal is generated as described in the Sampling and Conversion Start section.

Figure 10. Device Operation While A\_PWD is Toggling

## POWERDOWN/RESET

A low level on the PWD/RST pin puts the device in the powerdown phase. This is an asynchronous signal. As shown in Figure 11, the device is in the reset phase for the first  $t_{w6}$  period after a high-to-low transition of PWD/RST. During this period the output code is 3F80 (hex) to indicate that the device is in the reset phase. The device powers down if the PWD/RST pin continues to be low for a period of more than  $t_{w7}$ . Data is not valid for the first four conversions after a power-up (see Figure 11) or an end of reset (see Figure 12). The device is initialized during the first four conversions.

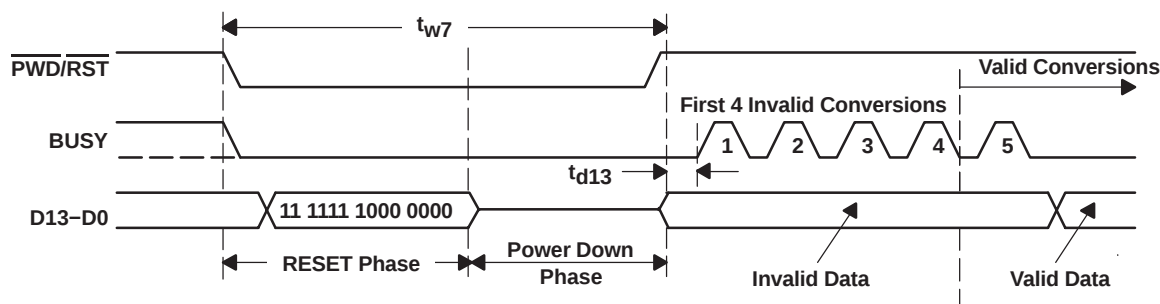


Figure 11. Device Power Down

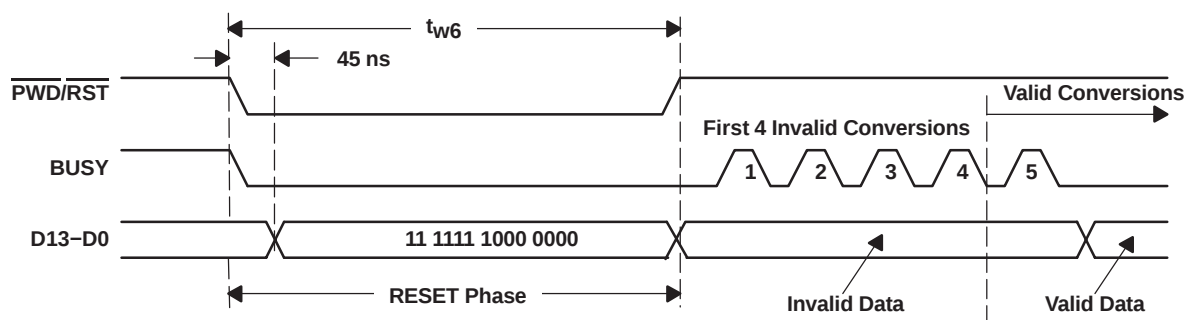


Figure 12. Device Reset

## TYPICAL CHARACTERISTICS<sup>(1)</sup>

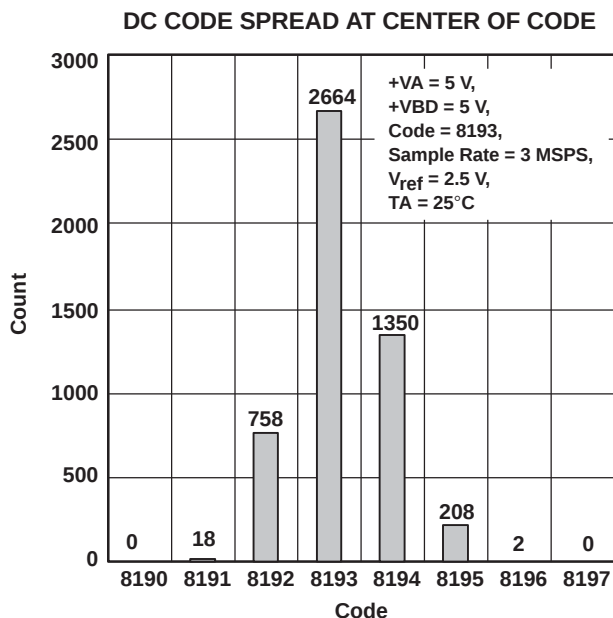


Figure 13

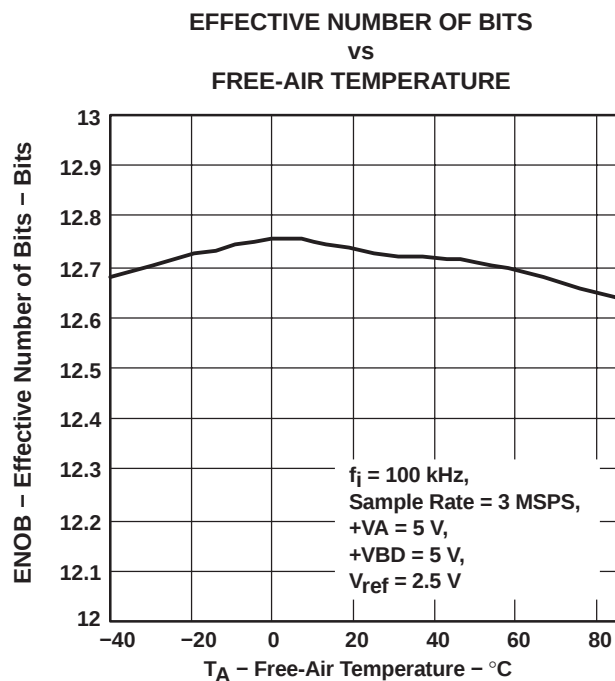


Figure 14

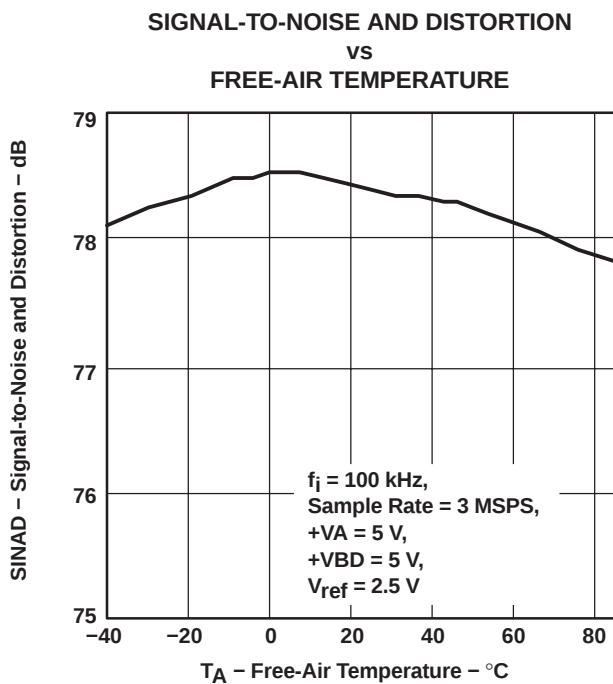


Figure 15

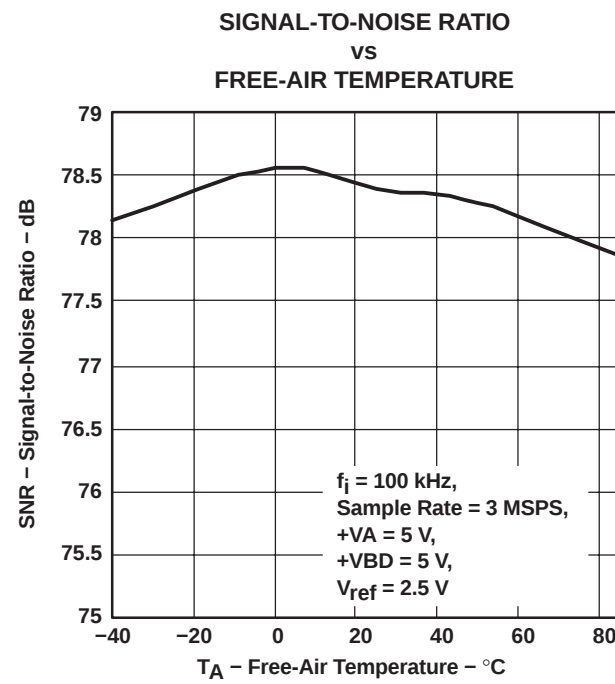


Figure 16

(1) At V<sub>ref</sub> = 2.5 V external, unless otherwise specified.

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SPURIOUS FREE DYNAMIC RANGE  
vs  
FREE-AIR TEMPERATURE

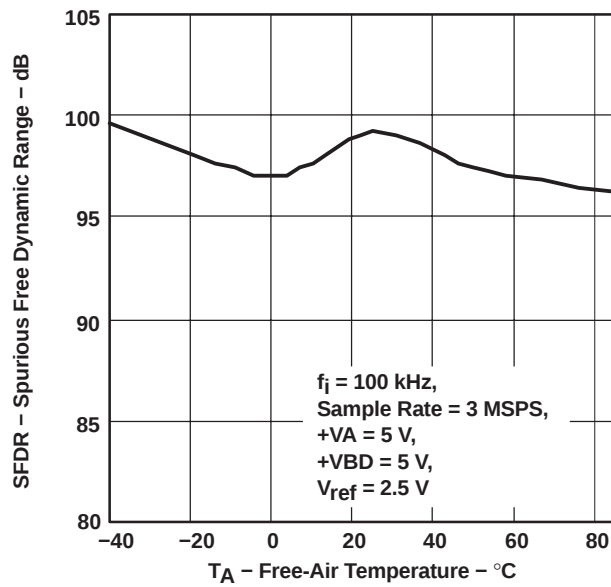


Figure 17

TOTAL HARMONIC DISTORTION  
vs  
FREE-AIR TEMPERATURE

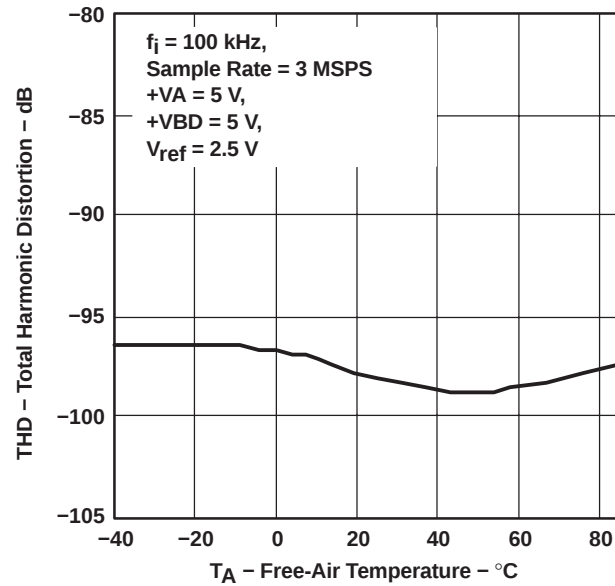


Figure 18

EFFECTIVE NUMBER OF BITS  
vs  
INPUT FREQUENCY

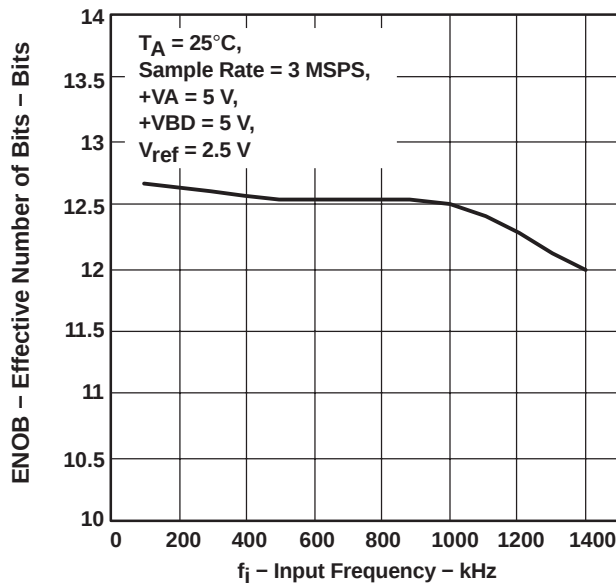


Figure 19

SIGNAL-TO-NOISE AND DISTORTION  
vs  
INPUT FREQUENCY

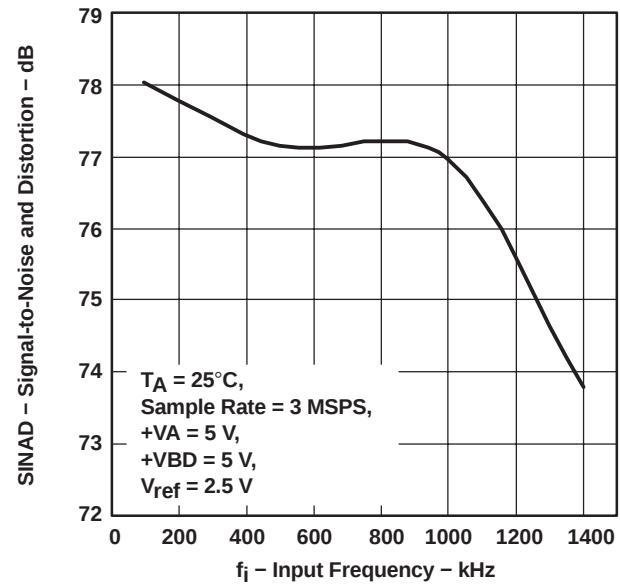


Figure 20

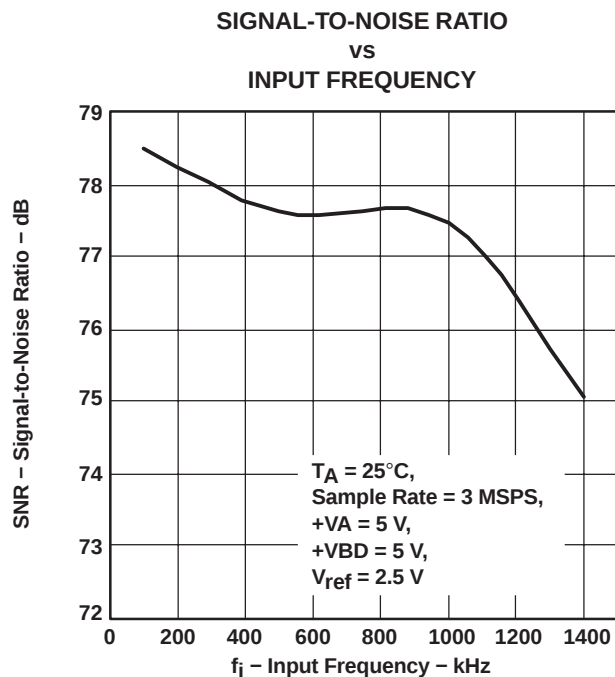


Figure 21

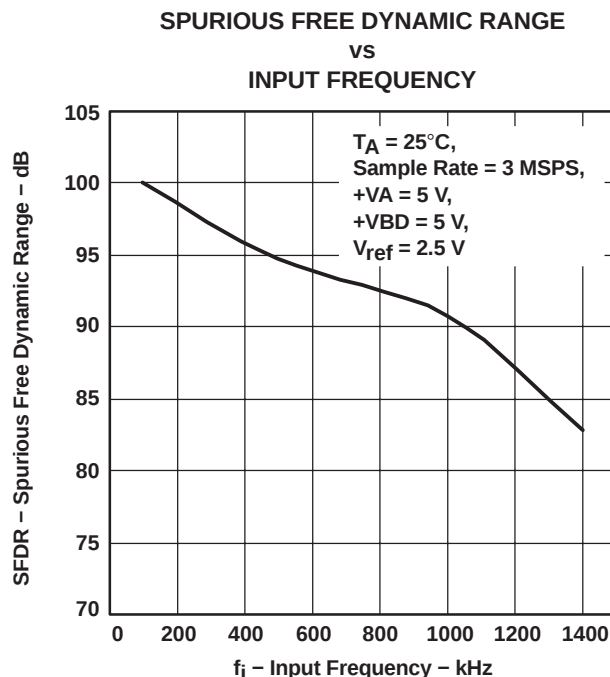


Figure 22

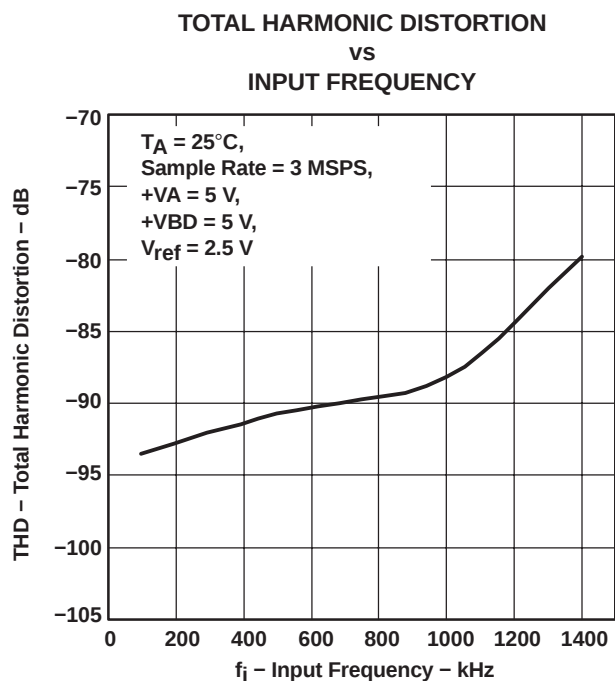


Figure 23

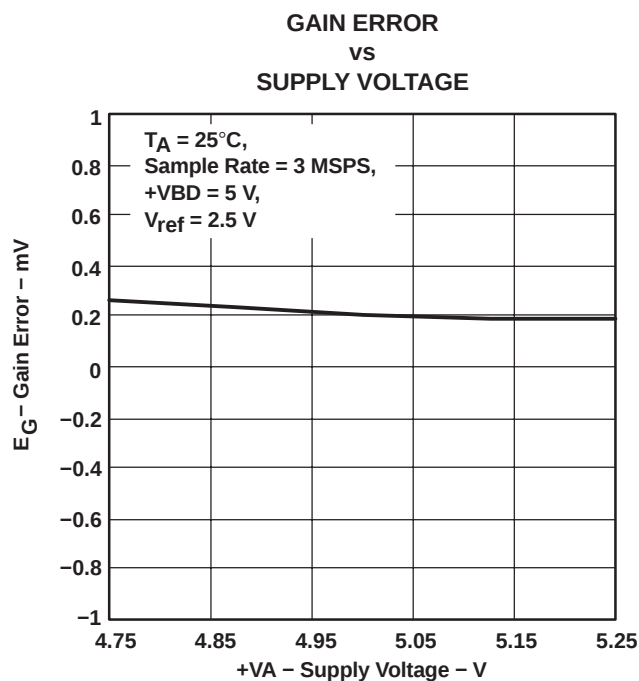


Figure 24

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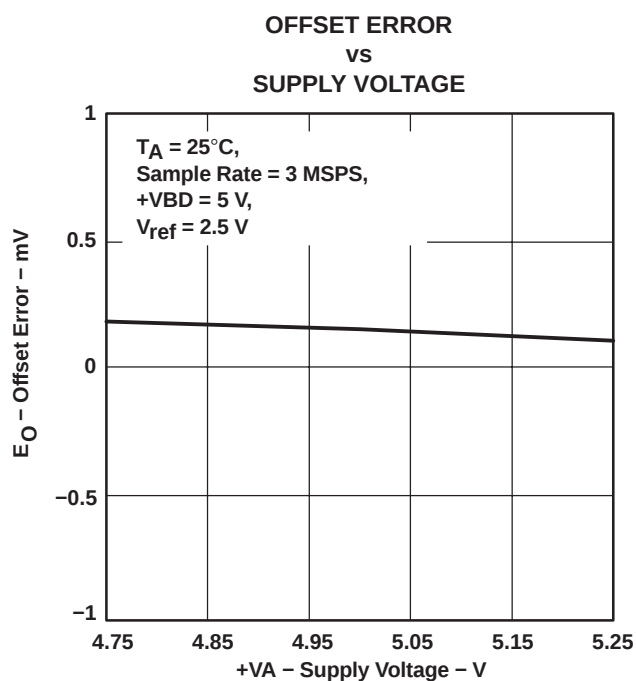


Figure 25

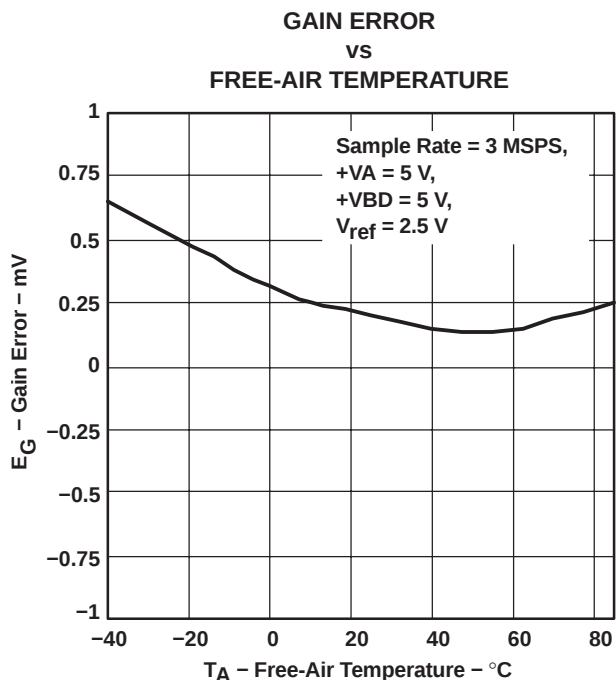


Figure 26

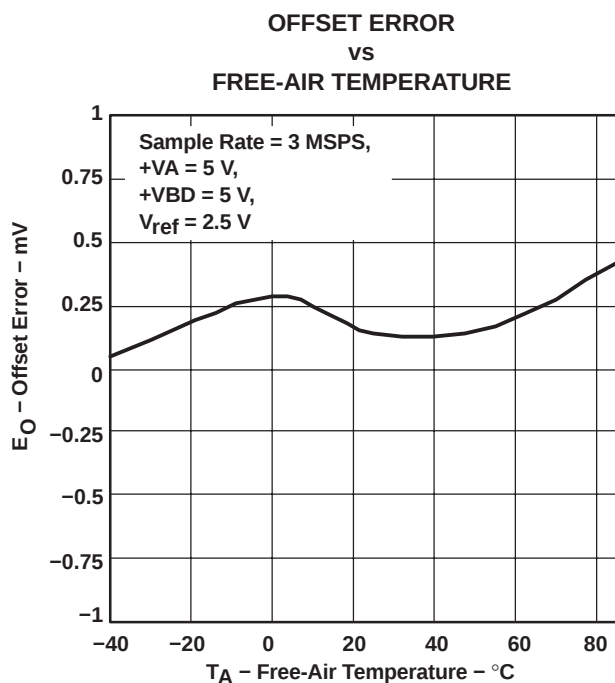


Figure 27

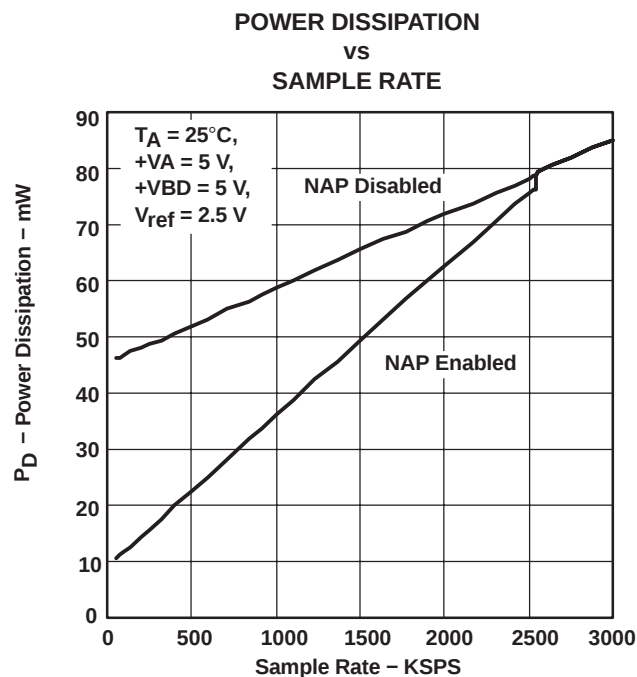


Figure 28

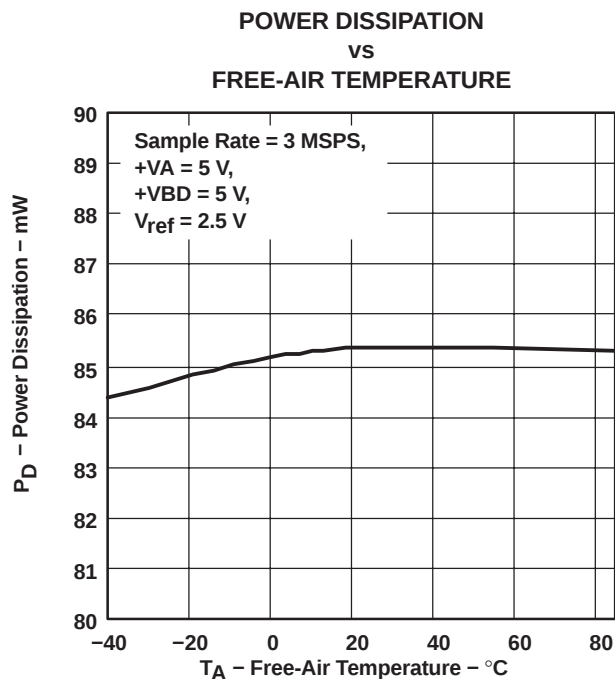


Figure 29

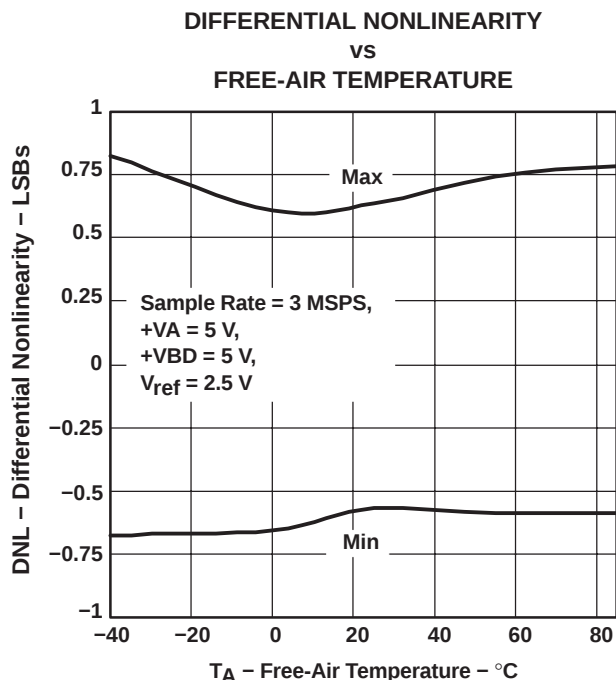


Figure 30

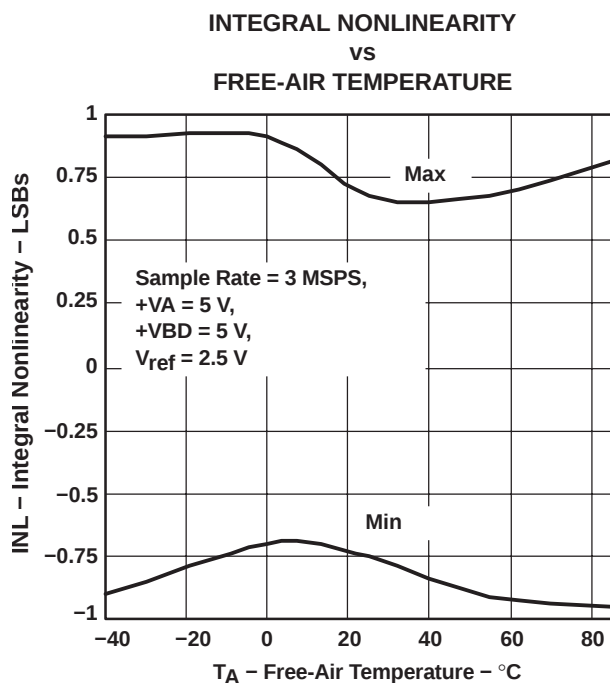


Figure 31

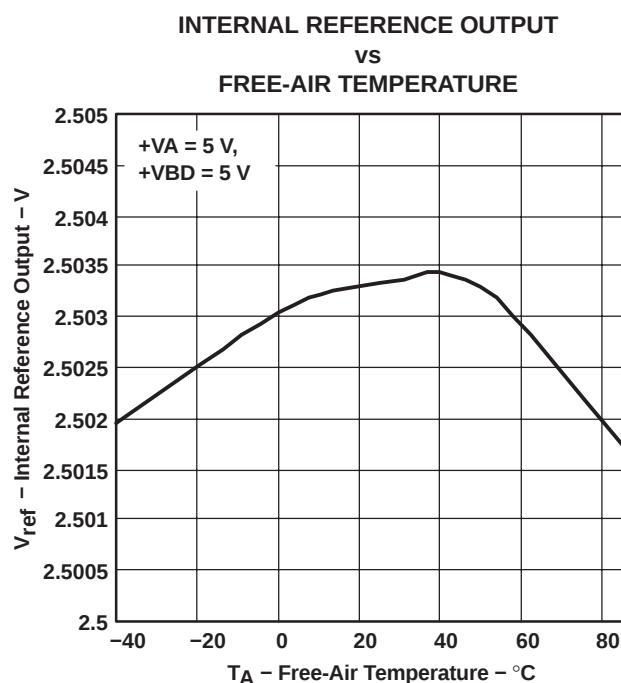
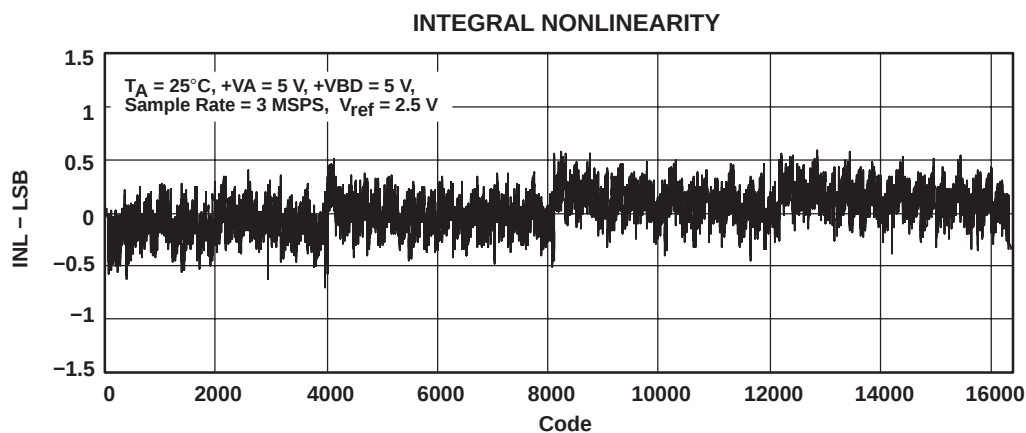
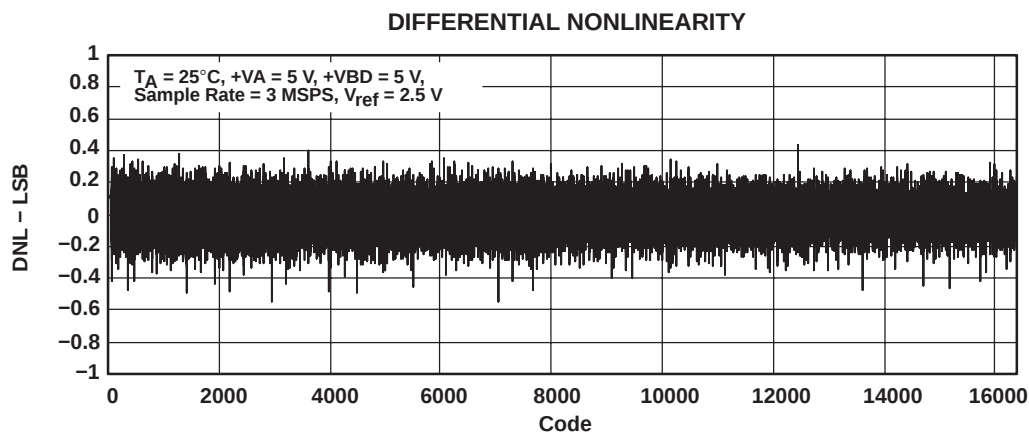
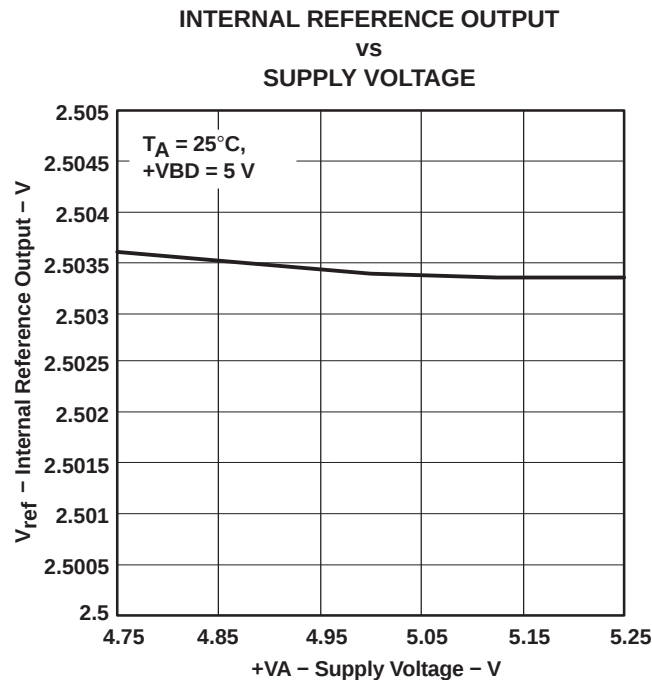


Figure 32



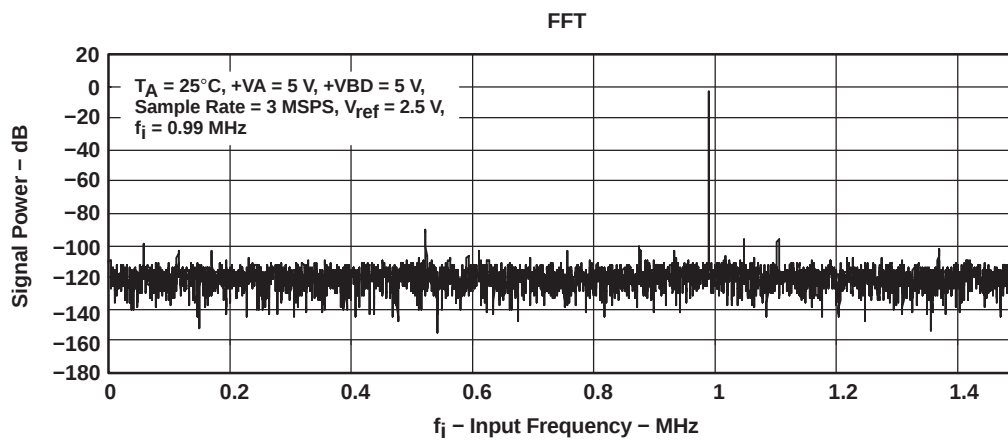


Figure 36

## PRINCIPLES OF OPERATION

The ADS7891 is a member of a family of high-speed successive approximation register (SAR) analog-to-digital converters (ADC). The architecture is based on charge redistribution, which inherently includes a sample/hold function.

The conversion clock is generated internally. The conversion time is 273 ns max (at 5 V +VBD).

The analog input is provided to two input pins: +IN and –IN. (Note that this is pseudo differential input and there are restrictions on –IN voltage range.) When a conversion is initiated, the difference voltage between these pins is sampled on the internal capacitor array. While a conversion is in progress, both inputs are disconnected from any internal function.

## REFERENCE

The ADS7891 has a built-in 2.5-V (nominal value) reference but can operate with an external reference. When an internal reference is used, pin 2 (REFOUT) should be connected to pin 1 (REFIN) with an 0.1-μF decoupling capacitor and a 1-μF storage capacitor between pin 2 (REFOUT) and pins 47, 48 (REFM). The internal reference of the converter is buffered. There is also a buffer from REFIN to CDAC. This buffer provides isolation between the external reference and the CDAC and also recharges the CDAC during conversion. It is essential to decouple REFOUT to AGND with a 0.1-μF capacitor while the device operates with an external reference.

## ANALOG INPUT

When the converter enters hold mode, the voltage difference between the +IN and –IN inputs is captured on the internal capacitor array. The voltage on the –IN input is limited to between –0.2 V and 0.2 V, thus allowing the input to reject a small signal which is common to both the +IN and –IN inputs. The +IN input has a range of –0.2 V to (+V<sub>ref</sub> +0.2 V). The input span (+IN – (–IN)) is limited from 0 V to VREF.

The input current on the analog inputs depends upon a number of factors: sample rate, input voltage, signal frequency, and source impedance. Essentially, the current into the ADS7891 charges the internal capacitor array during the sample period. After this capacitance has been fully charged, there is no further input current (this may not happen when a signal is moving continuously). The source of the analog input voltage must be able to charge the input capacitance (27 pF) to better than a 14-bit settling level with a step input within the acquisition time of the device. The step size can be selected equal to the maximum voltage difference between two consecutive samples at the maximum signal frequency. (Refer to Figure 39 for the suggested input circuit.) When the converter goes into hold mode, the input impedance is greater than 1 GΩ.

Care must be taken regarding the absolute analog input voltage. To maintain the linearity of the converter, both –IN and +IN inputs should be within the limits specified. Outside of these ranges, the converter's linearity may not meet specifications.

Care should be taken to ensure that +IN and –IN see the same impedance to the respective sources. (For example, both +IN and –IN are connected to a decoupling capacitor through a 21-Ω resistor as shown in Figure 39.) If this is not observed, the two inputs could have different settling times. This may result in an offset error, gain error, or linearity error which changes with temperature and input voltage.

## RECOMMENDED OPERATIONAL AMPLIFIERS

It is recommended to use the THS4031 or THS4211 op amps for the analog input. All of the performance figures in this data sheet are measured using the THS4031. Refer to Figure 39 for more information.

## DIGITAL INTERFACE

### TIMING AND CONTROL

Refer to the SAMPLING AND CONVERSION START section and the CONVERSION ABORT section.

### READING DATA

The ADS7891 outputs full parallel data in straight binary format as shown in Table 1. The parallel output is active when  $\overline{CS}$  and  $\overline{RD}$  are both low. There is a minimal quiet sampling period requirement around the falling edge of  $\overline{CONVST}$  as stated in the timing requirements section. Data reads or bus three-state operations should not be attempted within this period. Any other combination of  $\overline{CS}$  and  $\overline{RD}$  three-states the parallel output. Refer to Table 1 for ideal output codes.

**Table 1. Ideal Input Voltages and Output Codes<sup>(1)</sup>**

| DESCRIPTION      | ANALOG VALUE                | BINARY CODE       | HEX CODE |
|------------------|-----------------------------|-------------------|----------|
| Full scale       | $V_{ref} - 1 \text{ LSB}$   | 11 1111 1111 1111 | 3FFF     |
| Midscale         | $V_{ref}/2$                 | 10 0000 0000 0000 | 2000     |
| Midscale – 1 LSB | $V_{ref}/2 - 1 \text{ LSB}$ | 01 1111 1111 1111 | 1FFF     |
| Zero             | 0 V                         | 00 0000 0000 0000 | 0000     |

<sup>(1)</sup> Full-scale range =  $V_{ref}$  and least significant bit (LSB) =  $V_{ref}/16384$

The output data appears as a full 14-bit word (D13–D0) on pins DB13 – DB0 (MSB–LSB) if BYTE is low.

### READING THE DATA IN BYTE MODE

The result can also be read on an 8-bit bus for convenience by using pins DB13–DB6. In this case two reads are necessary; the first as before, leaving BYTE low and reading the 8 most significant bits on pins DB13–DB6, and then bringing BYTE high. When BYTE is high, the lower bits (D5–D0) followed by all zeros are on pins DB13 – DB6 (refer to Table 2).

These multi-word read operations can be performed with multiple active  $\overline{RD}$  signals (toggling) or with  $\overline{RD}$  tied low for simplicity.

**Table 2. Conversion Data Read Out**

| BYTE | DATA READ OUT |            |
|------|---------------|------------|
|      | DB13 – DB6    | DB5 – DB0  |
| High | D5 – D0, 00   | All zeroes |
| Low  | D13 – D6      | D5 – D0    |

Also refer to the DATA READ and DEVICE OPERATION AND DATA READ IN BACK-TO-BACK CONVERSION sections for more details.

### Reset

Refer to the POWERDOWN/RESET section for the device reset sequence.

It is recommended to reset the device after power on. A reset can be issued once the power has reached 95% of its final value.

$\overline{PWD}/\overline{RST}$  is an asynchronous active low input signal. A current conversion is aborted no later than 45 ns after the converter is in the reset mode. In addition, the device outputs a 3F80 code to indicate a reset condition. The converter returns back to normal operation mode immediately after the  $\overline{PWD}/\overline{RST}$  input is brought high.

Data is not valid for the first four conversions after a device reset.

### Powerdown

Refer to the POWERDOWN/RESET section for the device powerdown sequence.

The device enters powerdown mode if a  $\overline{PWD}/\overline{RST}$  low duration is extended for more than a period of  $t_{w7}$ .

The converter goes back to normal operation mode no later than a period of  $t_{d13}$  after the  $\overline{PWD}/\overline{RST}$  input is brought high.

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After this period, normal conversion and sampling operation can be started as discussed in previous sections. Data is not valid for the first four conversions after a device reset.

### ***Nap Mode***

Refer to the NAP MODE section in the DESCRIPTION AND TIMING DIAGRAMS section for information.

## APPLICATION INFORMATION

### LAYOUT

For optimum performance, care should be taken with the physical layout of the ADS7891 circuitry.

As the ADS7891 offers single-supply operation, it is often used in close proximity with digital logic, micro-controllers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to achieve acceptable performance from the converter.

The basic SAR architecture is sensitive to glitches or sudden changes on the power supply, reference, ground connections, and digital inputs that occur just prior to the end of sampling (within quiet sampling time) and just prior to latching the output of the analog comparator during the conversion phase. Thus, driving any single conversion for an n-bit SAR converter, there are n+1 windows in which large external transient voltages can affect the conversion result. Such glitches might originate from switching power supplies, nearby digital logic, or high power devices.

The degree of error in the digital output depends on the reference voltage, layout, and the exact timing of the external event.

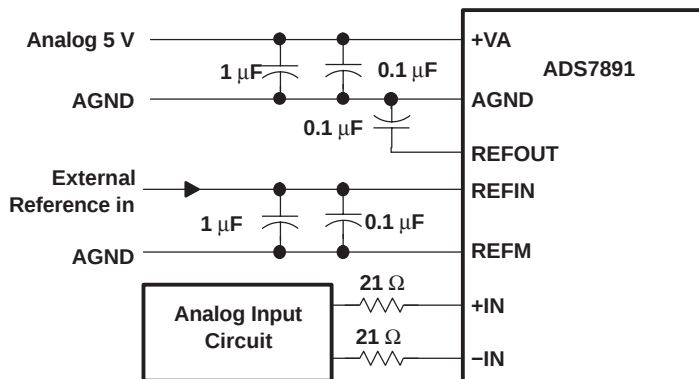
On average, the ADS7891 draws very little current from an external reference as the reference voltage is internally buffered. If the reference voltage is external and originates from an op amp, make sure that it can drive the bypass capacitor or capacitors without oscillation. A 0.1- $\mu$ F bypass capacitor and 1- $\mu$ F storage capacitor are recommended from REFIN (pin 1) directly to REFM (pin 48).

The AGND and BDGND pins should be connected to a clean ground point. In all cases, this should be the analog ground. Avoid connections which are too close to the grounding point of a micro-controller or digital signal processor. If required, run a ground trace directly from the converter to the power supply entry point. The ideal layout consists of an analog ground plane dedicated to the converter and associated analog circuitry.

As with the AGND connections, +VA should be connected to a 5-V power supply plane that is separate from the connection for +VBD and digital logic until they are connected at the power entry point onto the PCB. Power to the ADS7891 should be clean and well bypassed. A 0.1- $\mu$ F ceramic bypass capacitor should be placed as close to the device as possible. See Table 3 for the placement of capacitor. In addition to a 0.1- $\mu$ F capacitor, a 1- $\mu$ F capacitor is recommended. In some situations, additional bypassing may be required, such as a 100- $\mu$ F electrolytic capacitor or even a Pi filter made up of inductors and capacitors, all designed to essentially low-pass filter the 5-V supply, removing the high frequency noise.

**Table 3. Power Supply Decoupling Capacitor Placement**

| POWER SUPPLY PLANE                                                  | CONVERTER ANALOG SIDE                              | CONVERTER DIGITAL SIDE |
|---------------------------------------------------------------------|----------------------------------------------------|------------------------|
| SUPPLY PINS                                                         |                                                    |                        |
| Pairs of pins that require a shortest path to decoupling capacitors | (4,5), (9,8), (10,11), (13, 15), (43, 44) (46, 45) | (24, 25), (34, 35)     |
| Pins that require no decoupling                                     | 14, 12                                             |                        |



**Figure 37. Using External Reference**

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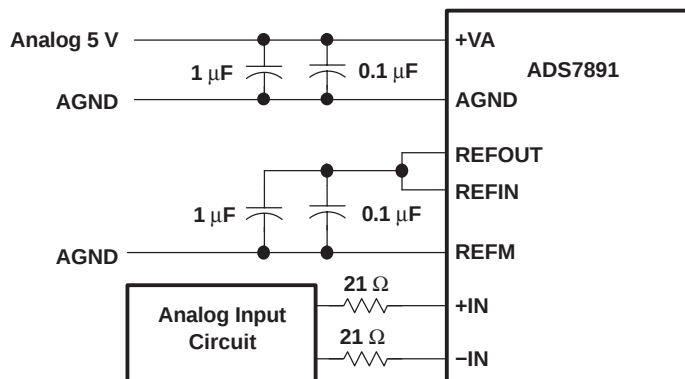


Figure 38. Using Internal Reference

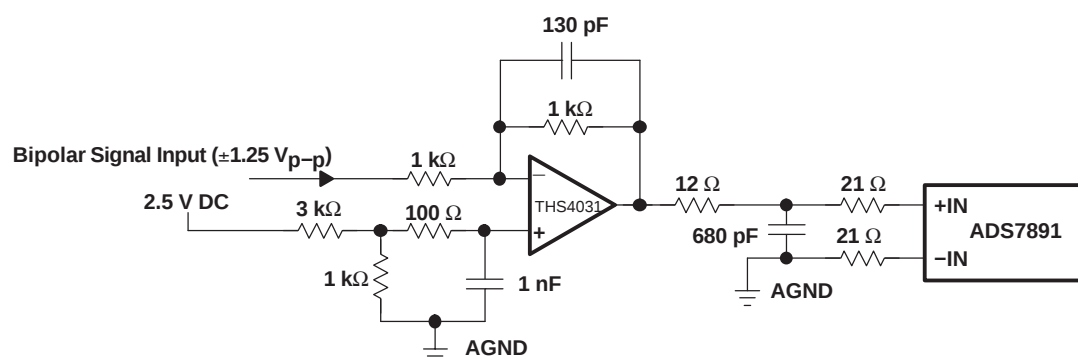


Figure 39. Typical Analog Input Circuit

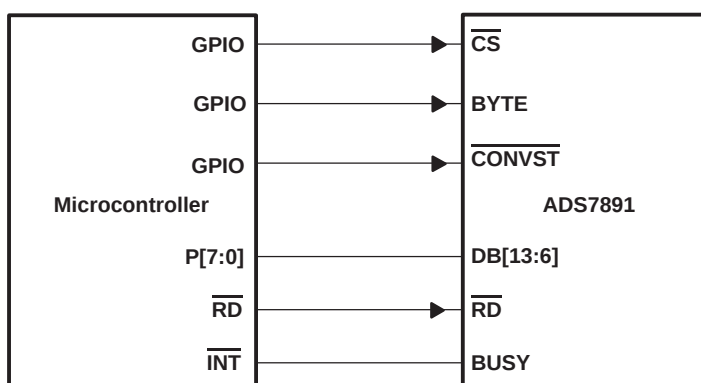


Figure 40. Interfacing With Microcontroller

## PACKAGING INFORMATION

| Orderable part number        | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">ADS7891IPFBR</a> | Active        | Production           | TQFP (PFB)   48 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | ADS7891I            |
| ADS7891IPFBR.B               | Active        | Production           | TQFP (PFB)   48 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | ADS7891I            |
| <a href="#">ADS7891IPFBT</a> | Active        | Production           | TQFP (PFB)   48 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | ADS7891I            |
| ADS7891IPFBT.B               | Active        | Production           | TQFP (PFB)   48 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | ADS7891I            |
| ADS7891IPFBTG4               | Active        | Production           | TQFP (PFB)   48 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | ADS7891I            |
| ADS7891IPFBTG4.B             | Active        | Production           | TQFP (PFB)   48 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 85    | ADS7891I            |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

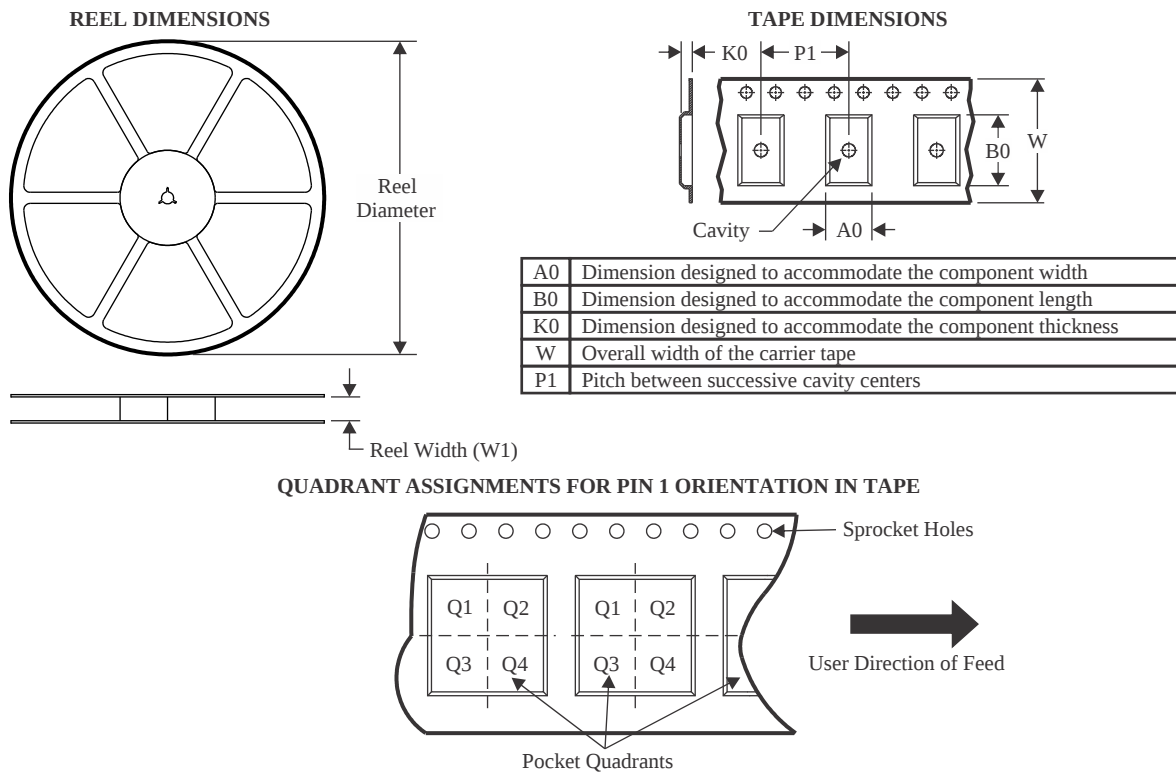
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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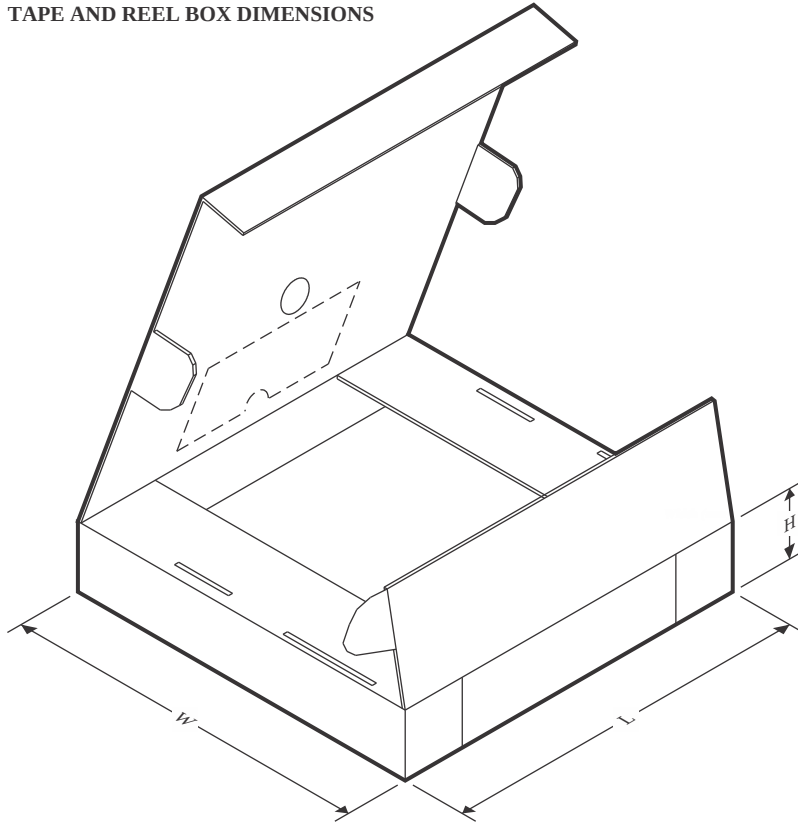
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ADS7891IPFBR | TQFP         | PFB             | 48   | 1000 | 330.0              | 16.4               | 9.6     | 9.6     | 1.5     | 12.0    | 16.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

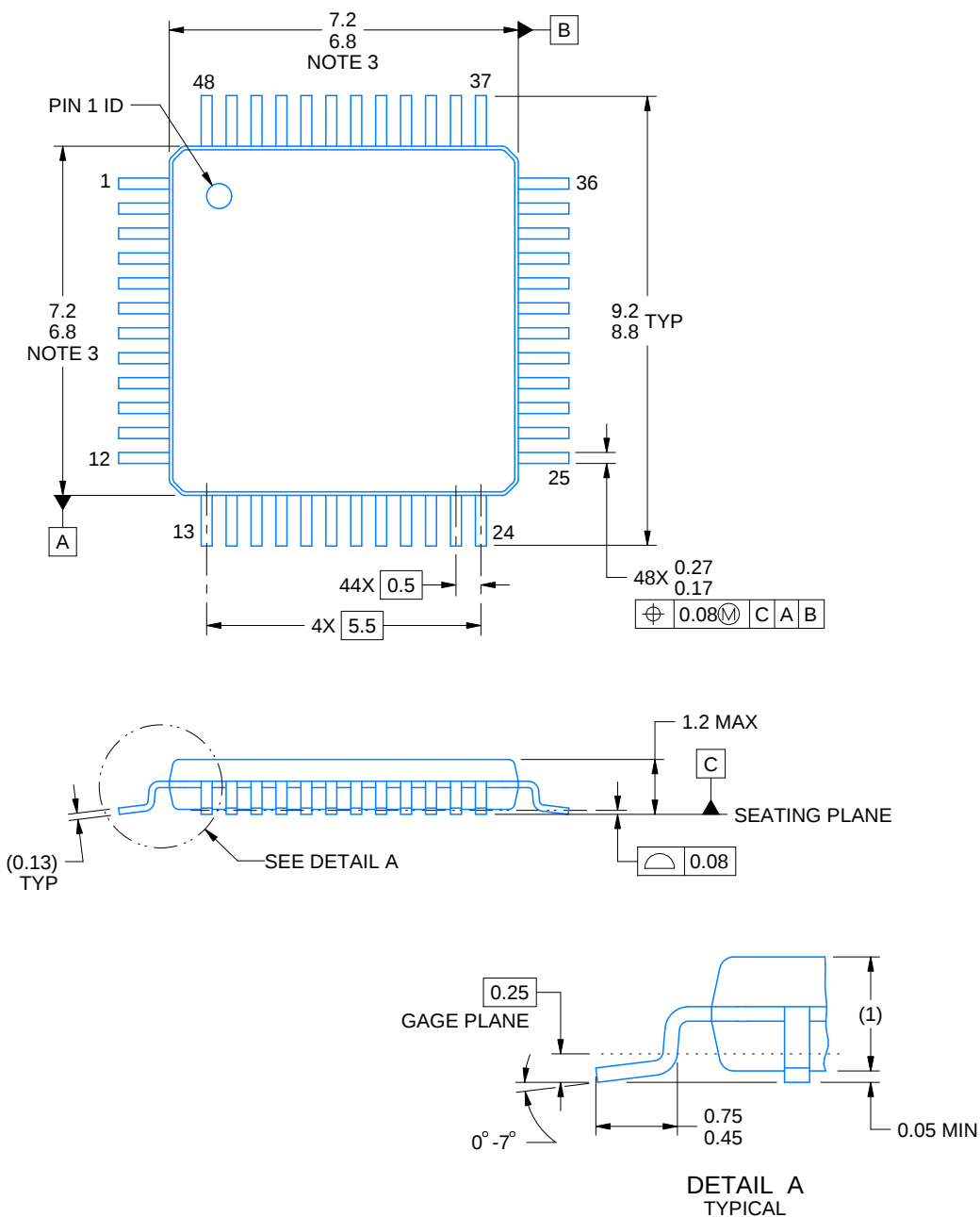
| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ADS7891IPFBR | TQFP         | PFB             | 48   | 1000 | 350.0       | 350.0      | 43.0        |



## PACKAGE OUTLINE

**TQFP - 1.2 mm max height**

## PLASTIC QUAD FLATPACK



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NOTES:

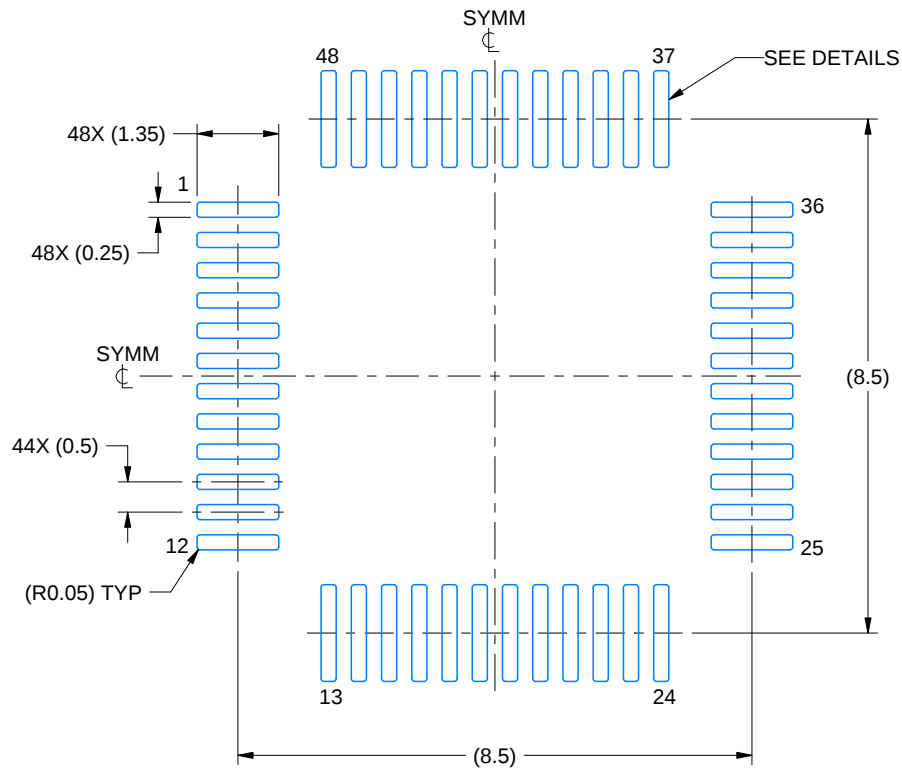
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC registration MS-026.

# EXAMPLE BOARD LAYOUT

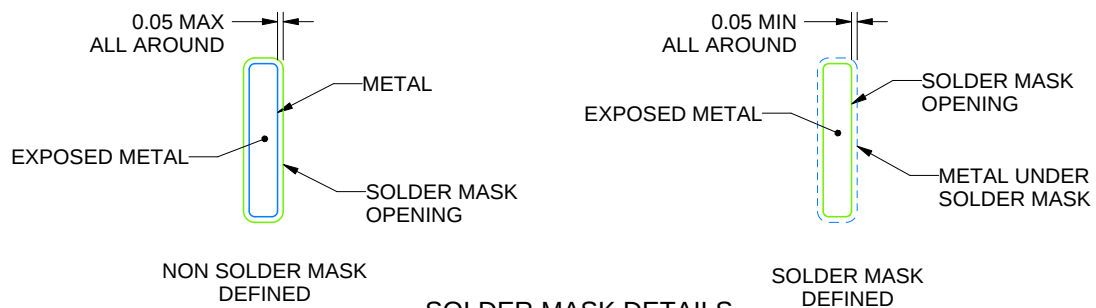
PFB0048A

TQFP - 1.2 mm max height

PLASTIC QUAD FLATPACK



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:8X



SOLDER MASK DETAILS

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NOTES: (continued)

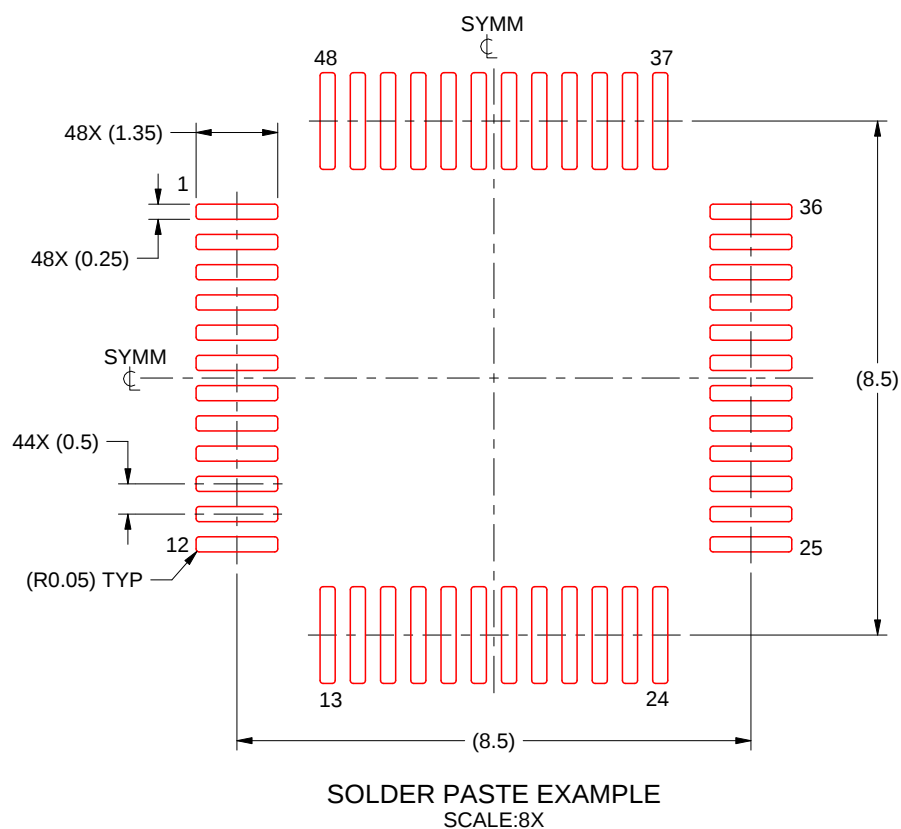
4. Publication IPC-7351 may have alternate designs.
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PFB0048A

TQFP - 1.2 mm max height

PLASTIC QUAD FLATPACK



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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
7. Board assembly site may have different recommendations for stencil design.

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